

**INTEGRATED CIRCUITS**

# DATA SHEET

## 74HCT9046A

### PLL with bandgap controlled VCO

Product specification

1999 Jan 11

Supersedes data of March 1994

File under Integrated Circuits, IC06

## PLL with bandgap controlled VCO

## 74HCT9046A

### FEATURES

- Low power consumption
- Centre frequency up to 17 MHz (typ.) at  $V_{CC} = 5.5\text{ V}$
- Choice of two phase comparators<sup>(1)</sup>:
  - EXCLUSIVE-OR (PC1)
  - Edge-triggered JK flip-flop (PC2)
- No dead zone of PC2
- Charge pump output on PC2, whose current is set by an external resistor  $R_b$
- Centre frequency tolerance  $\pm 10\%$
- Excellent voltage-controlled-oscillator (VCO) linearity
- Low frequency drift with supply voltage and temperature variations
- On chip bandgap reference
- Glitch free operation of VCO, even at very low frequencies
- Inhibit control for ON/OFF keying and for low standby power consumption
- Operation power supply voltage range 4.5 to 5.5 V
- Zero voltage offset due to op-amp buffering
- Output capability: standard
- $I_{CC}$  category: MSI.

### APPLICATIONS

- FM modulation and demodulation where a small centre frequency tolerance is essential
- Frequency synthesis and multiplication where a low jitter is required (e.g. Video picture-in-picture)
- Frequency discrimination

(1)  $R_b$  connected between pin 15 and ground: PC2 mode, with  $PCP_{OUT}$  at pin 2.  
Pin 15 left open or connected to  $V_{CC}$ : PC1 mode with  $PC1_{OUT}$  at pin 2.

- Tone decoding
- Data synchronization and conditioning
- Voltage-to-frequency conversion
- Motor-speed control.

### GENERAL DESCRIPTION

The 74HCT9046A is a high-speed Si-gate CMOS device. It is specified in compliance with "JEDEC standard no. 7A".

### QUICK REFERENCE DATA

$GND = 0\text{ V}$ ;  $T_{amb} = 25\text{ }^\circ\text{C}$ ;  $t_r = t_f \leq 6\text{ ns}$ .

SYMBOL	PARAMETER	CONDITIONS	TYP.	UNIT
$f_c$	VCO centre frequency	$C_1 = 40\text{ pF}$ ; $R_1 = 3\text{ k}\Omega$ ; $V_{CC} = 5\text{ V}$	16	MHz
$C_I$	input capacitance		3.5	pF
$C_{PD}$	power dissipation capacitance per package	notes 1 and 2	20	pF

### Notes

1.  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu\text{W}$ )
  - a)  $P_D = C_{PD} \times V_{CC}^2 \times f_i + \Sigma(C_L \times V_{CC}^2 \times f_o)$  where:
    - b)  $f_i$  = input frequency in MHz;  $C_L$  = output load capacity in pF;  
 $f_o$  = output frequency in MHz;  $V_{CC}$  = supply voltage in V;  
 $\Sigma(C_L \times V_{CC}^2 \times f_o)$  = sum of the outputs.
2. Applies to the phase comparator section only (inhibit = HIGH). For power dissipation of the VCO and demodulator sections see Figs 26 to 28.

### ORDERING INFORMATION

EXTENDED TYPE NUMBER	PACKAGE			
	PINS	PIN POSITION	MATERIAL	CODE
74HCT9046AN	16	DIL16	plastic	SOT38Z
74HCT9046AD	16	SO16	plastic	SOT109A

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PINNING

SYMBOL	PIN	DESCRIPTION
GND	1	ground (0 V) (phase comparators)
PC1 <sub>OUT</sub> / PCP <sub>OUT</sub>	2	phase comparator 1 output/phase comparator pulse output
COMP <sub>IN</sub>	3	comparator input
VCO <sub>OUT</sub>	4	VCO output
INH	5	inhibit input
C1 <sub>A</sub>	6	capacitor C1 connection A
C1 <sub>B</sub>	7	capacitor C1 connection B
GND	8	ground (0 V) (VCO)
VCO <sub>IN</sub>	9	VCO input
DEM <sub>OUT</sub>	10	demodulator output
R1	11	resistor R1 connection
R2	12	resistor R2 connection
PC2 <sub>OUT</sub>	13	phase comparator 2 output (current source adjustable with R <sub>b</sub> )
SIG <sub>IN</sub>	14	signal input
R <sub>b</sub>	15	bias resistor (R <sub>b</sub> ) connection
V <sub>CC</sub>	16	supply voltage

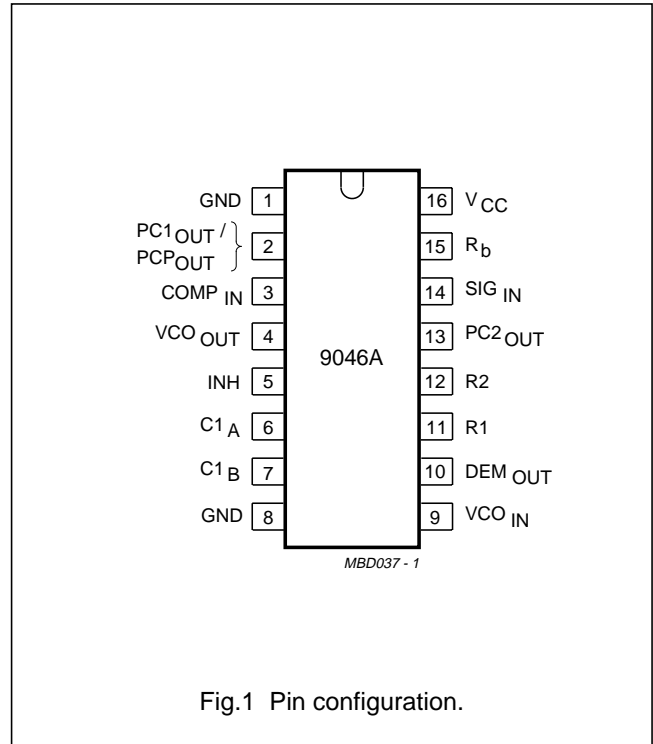


Fig.1 Pin configuration.

LOGIC/FUNCTIONAL SYMBOLS AND DIAGRAMS

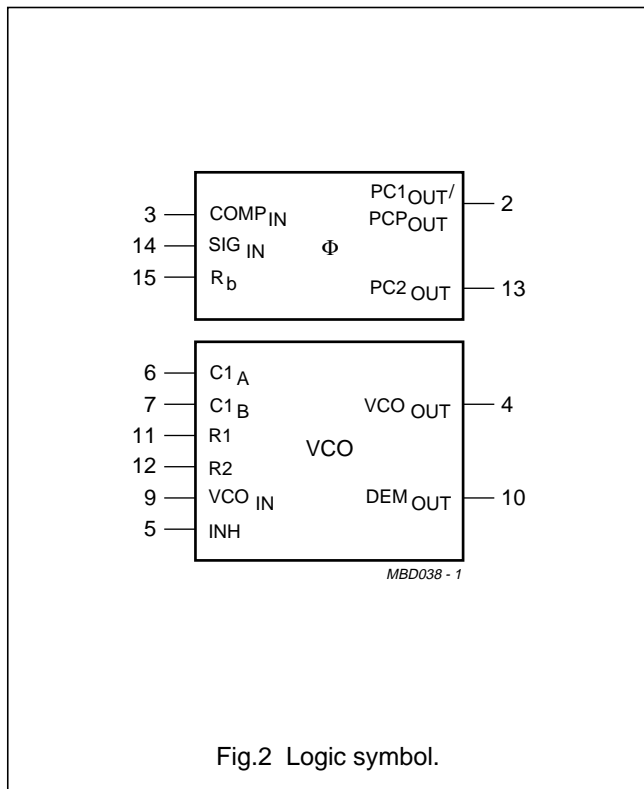


Fig.2 Logic symbol.

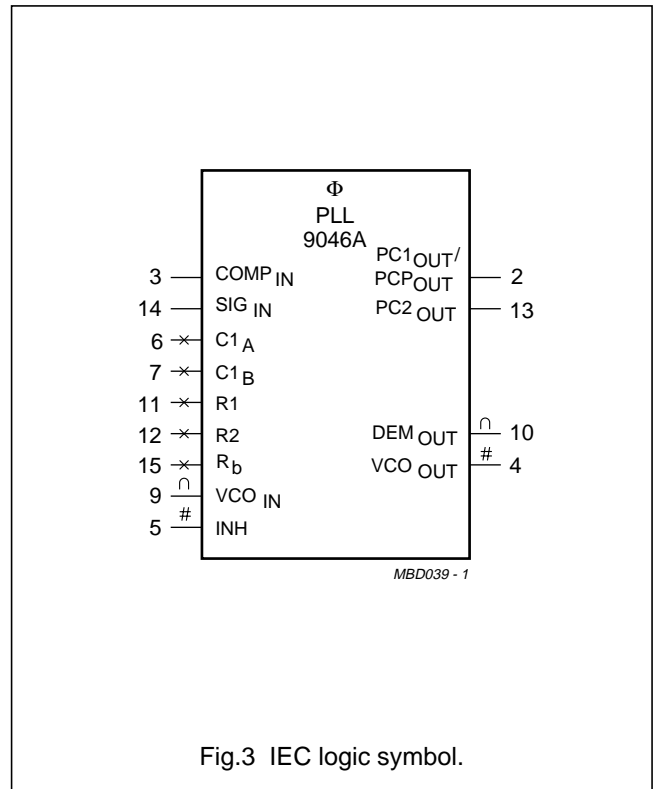


Fig.3 IEC logic symbol.



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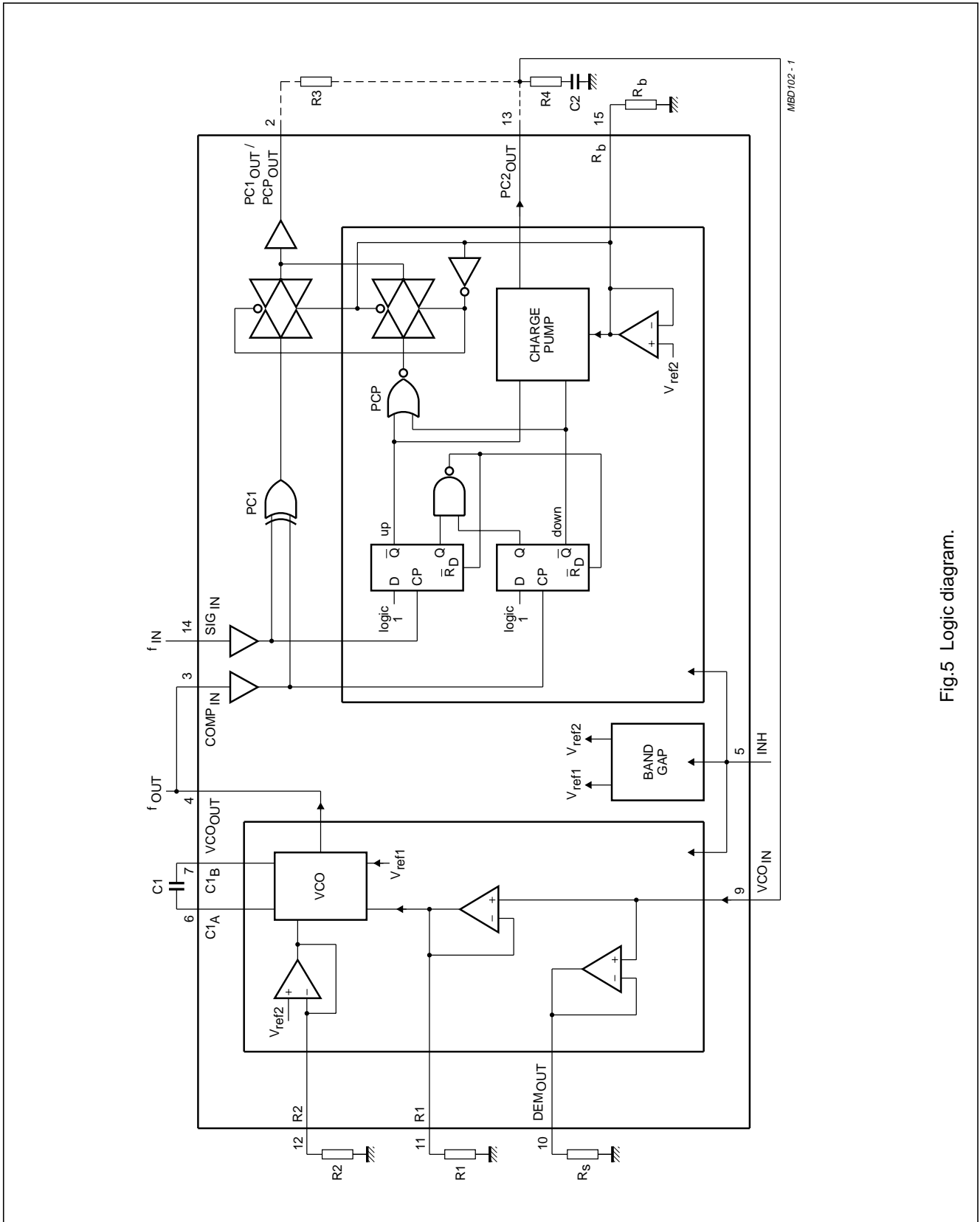


Fig.5 Logic diagram.

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### FUNCTIONAL DESCRIPTION

The 74HCT9046A is a phase-locked-loop circuit that comprises a linear VCO and two different phase comparators (PC1 and PC2) with a common signal input amplifier and a common comparator input (see Fig.4). The signal input can be directly coupled to large voltage signals (CMOS level), or indirectly coupled (with a series capacitor) to small voltage signals. A self-bias input circuit keeps small voltage signals within the linear region of the input amplifiers. With a passive low-pass filter, the '9046A' forms a second-order loop PLL.

The principle of this phase-locked-loop is based on the familiar HCT4046A. However extra features are built in, allowing very high performance phase-locked-loop applications. This is done, at the expense of PC3, which is skipped in this HCT9046A. The PC2 is equipped with a current source output stage here. Further a bandgap is applied for all internal references, allowing a small centre frequency tolerance. The details are summed up in the next section called: "Differences with respect to the familiar HCT4046A". If one is familiar with the HCT4046A already, it will do to read this section only.

### DIFFERENCES WITH RESPECT TO THE FAMILIAR HCT4046A

- A centre frequency tolerance of maximum  $\pm 10\%$ .
- The on board bandgap sets the internal references resulting in a minimal frequency shift at supply voltage variations and temperature variations.
- The value of the frequency offset is determined by an internal reference voltage of 2.5 V instead of  $V_{CC} - 0.7$  V. In this way the offset frequency will not shift over the supply voltage range.
- A current switch charge pump output on PC2 allows a virtually ideal performance of PC2. The gain of PC2 is independent of the voltage across the low-pass filter. Further a passive low-pass filter in the loop achieves an active performance now. The influence of the parasitic capacitance of the PC2 output plays no role here, resulting in a true correspondence of the output correction pulse and the phase difference even up to phase differences as small as a few nanoseconds.
- Because of its linear performance without dead zone, higher impedance values for the filter, hence lower C-values, can now be chosen. Correct operation will not be influenced by parasitic capacitances as in the instance with voltage source output of the 4046A.
- No PC3 on pin 15 but instead a resistor connected to GND, which sets the load/unload currents of the charge pump (PC2).
- Extra GND pin at pin 1 to allow an excellent FM demodulator performance even at 10 MHz and higher.
- Combined function of pin 2. If pin 15 is connected to  $V_{CC}$  (no bias resistor  $R_b$ ) pin 2 has its familiar function viz. output of PC1. If at pin 15 a resistor ( $R_b$ ) is connected to GND it is assumed that PC2 has been chosen as phase comparator. Connection of  $R_b$  is sensed by internal circuitry and this changes the function of pin 2 into a lock detect output ( $PCP_{OUT}$ ) with the same characteristics as  $PCP_{OUT}$  of pin 1 of the well known 74HCT4046A.

- The inhibit function differs. For the HCT4046A a HIGH level at the inhibit input (INH) disables the VCO and demodulator, while a LOW level turns both on. For the 74HCT9046A a HIGH level on the inhibit input disables the whole circuit to minimize standby power consumption.

### VCO

The VCO requires one external capacitor C1 (between C1<sub>A</sub> and C1<sub>B</sub>) and one external resistor R1 (between R1 and GND) or two external resistors R1 and R2 (between R1 and GND, and R2 and GND). Resistor R1 and capacitor C1 determine the frequency range of the VCO. Resistor R2 enables the VCO to have a frequency offset if required (see Fig.5).

The high input impedance of the VCO simplifies the design of the low-pass filters by giving the designer a wide choice of resistor/capacitor ranges. In order not to load the low-pass filter, a demodulator output of the VCO input voltage is provided at pin 10 ( $DEM_{OUT}$ ). The  $DEM_{OUT}$  voltage equals that of the VCO input. If  $DEM_{OUT}$  is used, a load resistor ( $R_s$ ) should be connected from pin 10 to GND; if unused,  $DEM_{OUT}$  should be left open. The VCO output ( $VCO_{OUT}$ ) can be connected directly to the comparator input ( $COMP_{IN}$ ), or connected via a frequency-divider. The VCO output signal has a duty factor of 50% (maximum expected deviation 1%), if the VCO input is held at a constant DC level. A LOW level at the inhibit input (INH) enables the VCO and demodulator, while a HIGH level turns both off to minimize standby power consumption.

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### Phase comparators

The signal input (SIG<sub>IN</sub>) can be directly coupled to the self-biasing amplifier at pin 14, provided that the signal swing is between the standard HC family input logic levels. Capacitive coupling is required for signals with smaller swings.

#### PHASE COMPARATOR 1 (PC1)

This circuit is an EXCLUSIVE-OR network. The signal and comparator input frequencies ( $f_i$ ) must have a 50% duty factor to obtain the maximum locking range. The transfer characteristic of PC1, assuming ripple ( $f_r = 2f_i$ ) is suppressed, is:

$$V_{\text{DEMOUT}} = \frac{V_{\text{CC}}}{\pi} (\Phi_{\text{SIGIN}} - \Phi_{\text{COMPIN}})$$

where:

$V_{\text{DEMOUT}}$  is the demodulator output at pin 10.

$V_{\text{DEMOUT}} = V_{\text{PC1OUT}}$  (via low-pass).

The phase comparator gain is:

$$K_p = \frac{V_{\text{CC}}}{\pi} (V/r)$$

The average output voltage from PC1, fed to the VCO input via the low-pass filter and seen at the demodulator output at pin 10 ( $V_{\text{DEMOUT}}$ ), is the resultant of the phase differences of signals (SIG<sub>IN</sub>) and the comparator input (COMP<sub>IN</sub>) as shown in Fig.6. The average of  $V_{\text{DEMOUT}}$  is equal to  $\frac{1}{2}V_{\text{CC}}$  when there is no signal or noise at SIG<sub>IN</sub> and with this input the VCO oscillates at the centre frequency ( $f_c$ ). Typical waveforms for the PC1 loop locked at  $f_c$  are shown in Fig.7. This figure also shows the actual waveforms across the VCO capacitor at pins 6 and 7 ( $V_{\text{C1A}}$  and  $V_{\text{C1B}}$ ) to show the relation between these ramps and the VCO<sub>OUT</sub> voltage.

The frequency capture range ( $2f_c$ ) is defined as the frequency range of input signals on which the PLL will lock if it was initially out-of-lock. The frequency lock range ( $2f_L$ ) is defined as the frequency range of the input signals on which the loop will stay locked if it was initially in lock. The capture range is smaller or equal to the lock range.

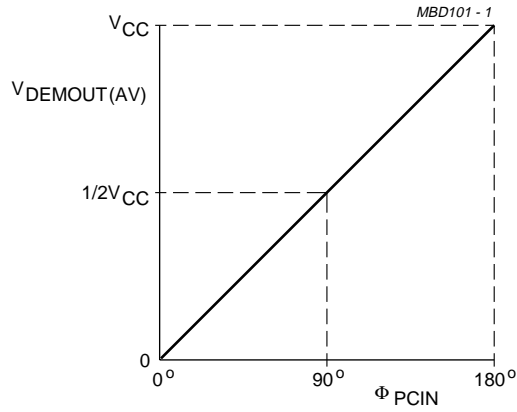
With PC1, the capture range depends on the low-pass filter characteristics and can be made as large as the lock range. This configuration remains locked even with very noisy input signals. Typical behaviour of this type of phase comparator is that it may lock to input frequencies close to the harmonics of the VCO centre frequency.

#### PHASE COMPARATOR 2 (PC2)

This is a positive edge-triggered phase and frequency detector. When the PLL is using this comparator, the loop is controlled by positive signal transitions and the duty factors of SIG<sub>IN</sub> and COMP<sub>IN</sub> are not important. PC2 comprises two D-type flip-flops, control gating and a 3-state output stage with sink and source transistors acting as current sources, henceforth called charge pump output of PC2. The circuit functions as an up-down counter (Fig.5) where SIG<sub>IN</sub> causes an up-count and COMP<sub>IN</sub> a down count. The current switch charge pump output allows a virtually ideal performance of PC2, due to appliance of some pulse overlap of the up and down signals. See Fig.8a.

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$$V_{\text{DEMOUT}} = V_{\text{PC1OUT}} = \frac{V_{\text{CC}}}{\pi} (\Phi_{\text{SIGIN}} - \Phi_{\text{COMPIN}})$$

$$\Phi_{\text{PCIN}} = (\Phi_{\text{SIGIN}} - \Phi_{\text{COMPIN}})$$

Fig.6 Phase comparator 1; average output voltage as a function of input phase difference.

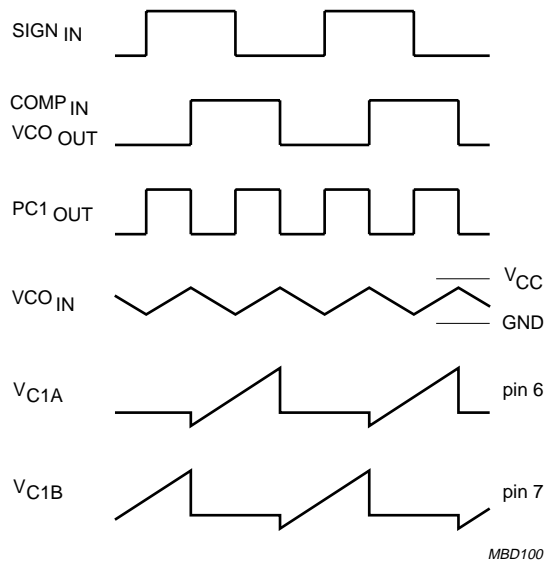


Fig.7 Typical waveforms for PLL using phase comparator 1; loop-locked at  $f_c$ .



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The pump current  $I_P$  is independent from the supply voltage and is set by the internal bandgap reference of 2.5 V.

$$I_P = 17 \times \frac{2.5}{R_b} \text{ (A)}$$

$R_b$  is the external bias resistor between pin 15 and ground.

The current and voltage transfer function of PC2 are shown in Fig.9.

The phase comparator gain is:

$$K_p = \frac{|I_P|}{2\pi} \text{ (A/r)}$$

Typical waveforms for the PC2 loop locked at  $f_c$  are shown in Fig.10.

When the frequencies of  $SIG_{IN}$  and  $COMP_{IN}$  are equal but the phase of  $SIG_{IN}$  leads that of  $COMP_{IN}$ , the up output driver at  $PC2_{OUT}$  is held 'ON' for a time corresponding to the phase difference ( $\Phi_{PCIN}$ ). When the phase of  $SIG_{IN}$  lags that of  $COMP_{IN}$ , the down or sink driver is held 'ON'.

When the frequency of  $SIG_{IN}$  is higher than that of  $COMP_{IN}$ , the source output driver is held 'ON' for most of the input signal cycle time and for the remainder of the cycle time both drivers are 'OFF' (3-state). If the  $SIG_{IN}$  frequency is lower than the  $COMP_{IN}$  frequency, then it is the sink driver that is held 'ON' for most of the cycle. Subsequently the voltage at the capacitor (C2) of the low-pass filter connected to  $PC2_{OUT}$  varies until the signal and comparator inputs are equal in both phase and frequency. At this stable point the voltage on C2 remains constant as the PC2 output is in 3-state and the VCO input at pin 9 is a high impedance. Also in this condition the signal at the phase comparator pulse output ( $PCP_{OUT}$ ) has a minimum output pulse width equal to the overlap time, so can be used for indicating a locked condition.

Thus for PC2 no phase difference exists between  $SIG_{IN}$  and  $COMP_{IN}$  over the full frequency range of the VCO. Moreover, the power dissipation due to the low-pass filter is reduced because both output drivers are OFF for most of the signal input cycle. It should be noted that the PLL lock range for this type of phase comparator is equal to the capture range and is independent of the low-pass filter. With no signal present at  $SIG_{IN}$  the VCO adjust, via PC2, to its lowest frequency.

By using current sources as charge pump output on PC2, the dead zone or backlash time could be reduced to zero. Also, the pulse widening due to the parasitic output capacitance plays no role here. This enables a linear transfer function, even in the vicinity of the zero crossing. The differences between a voltage switch charge pump and a current switch charge pump are shown in Fig.11.

The design of the low-pass filter is somewhat different when using current sources. The external resistor R3 is no longer present when using PC2 as phase comparator. The current source is set by  $R_b$ . A simple capacitor behaves as an ideal integrator now, because the capacitor is charged by a constant current. The transfer function of the voltage switch charge pump may be used. In fact it is even more valid, because the transfer function is no longer restricted for small changes only. Further the current is independent from both the supply voltage and the voltage across the filter. For one that is familiar with the low-pass filter design of the 4046A a relation may show how  $R_b$  relates with a fictive series resistance, called R3'.

This relation can be derived by assuming first that a voltage controlled switch PC2 of the 4046A is

connected to the filter capacitance C2 via this fictive R3' (see Fig.8b). Then during the PC2 output pulse the charge current equals:

$$|I_P| = \frac{V_{CC} - V_{C2(0)}}{R3'}$$

With the initial voltage  $V_{C2(0)}$  at:

$$\frac{1}{2}V_{CC} = 2.5 \text{ V}, |I_P| = \frac{2.5}{R3'}$$

As shown before the charge current of the current switch of the 9046A is:

$$|I_P| = 17 \times \frac{2.5}{R_b}$$

Hence:

$$R3' = \frac{R_b}{17} \text{ (}\Omega\text{)}$$

Using this equivalent resistance R3' for the filter design the voltage can now be expressed as a transfer function of PC2; assuming ripple ( $f_r = f_i$ ) is suppressed, as:

$$K_{PC2} = \frac{5}{4\pi} \text{ (V/r)}$$

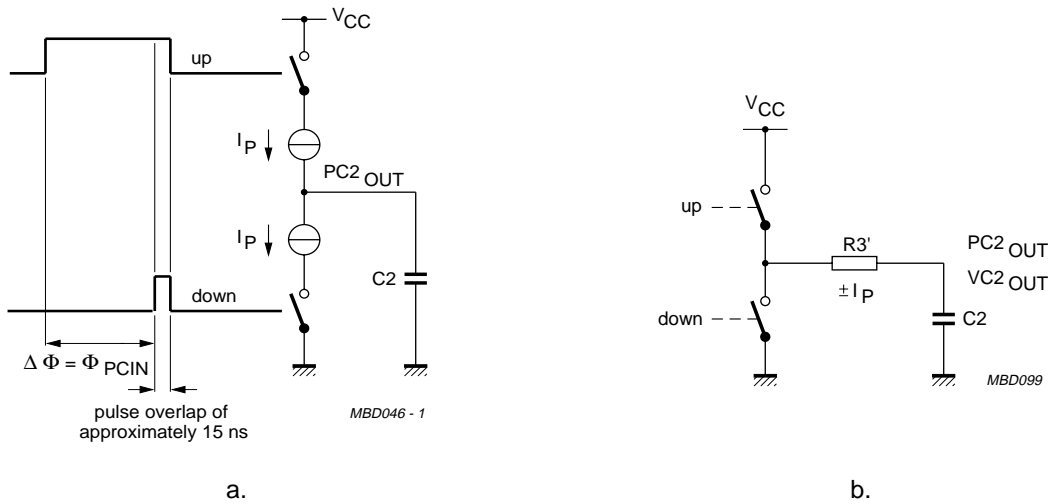
Again this illustrates the supply voltage independent behaviour of PC2.

Examples of PC2 combined with a passive filter are shown in Figs 12 and 13. Figure 12 shows that PC2 with only a C2 filter behaves as a high-gain filter. For stability the damped version of Fig.13 with series resistance R4 is preferred.

Practical design values for  $R_b$  are between 25 and 250 k $\Omega$  with  $R3' = 1.5$  to 15 k $\Omega$  for the filter design. Higher values for R3' require lower values for the filter capacitance which is very advantageous at low values the loop natural frequency  $\omega_n$ .

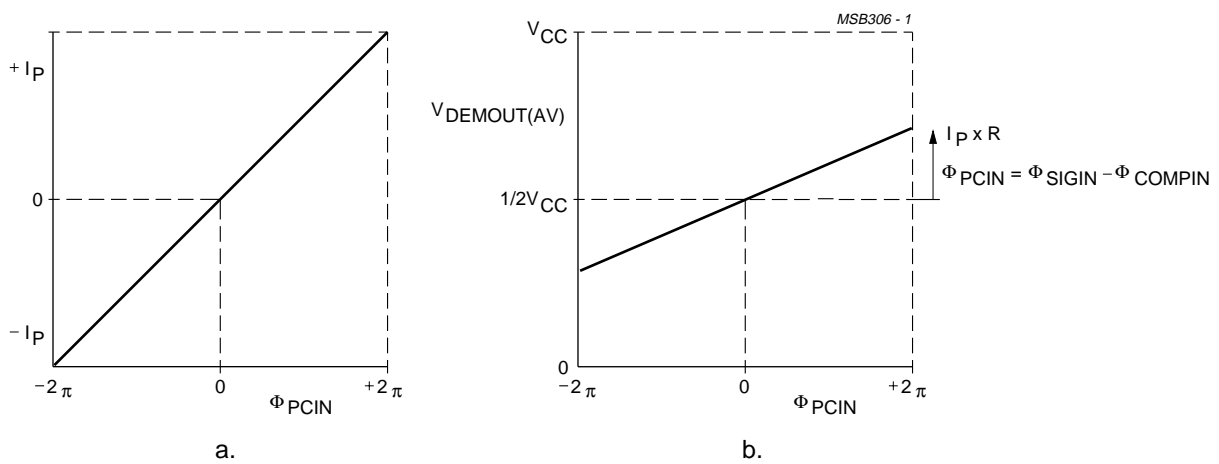
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- a. At every  $\Delta\Phi$ , even at zero  $\Delta\Phi$  both switches are closed simultaneously for a short period (typically 15 ns).
- b. Comparable voltage-controlled switch.

Fig.8 The current switch charge pump output of PC2.



Two kinds of transfer functions may be regarded:

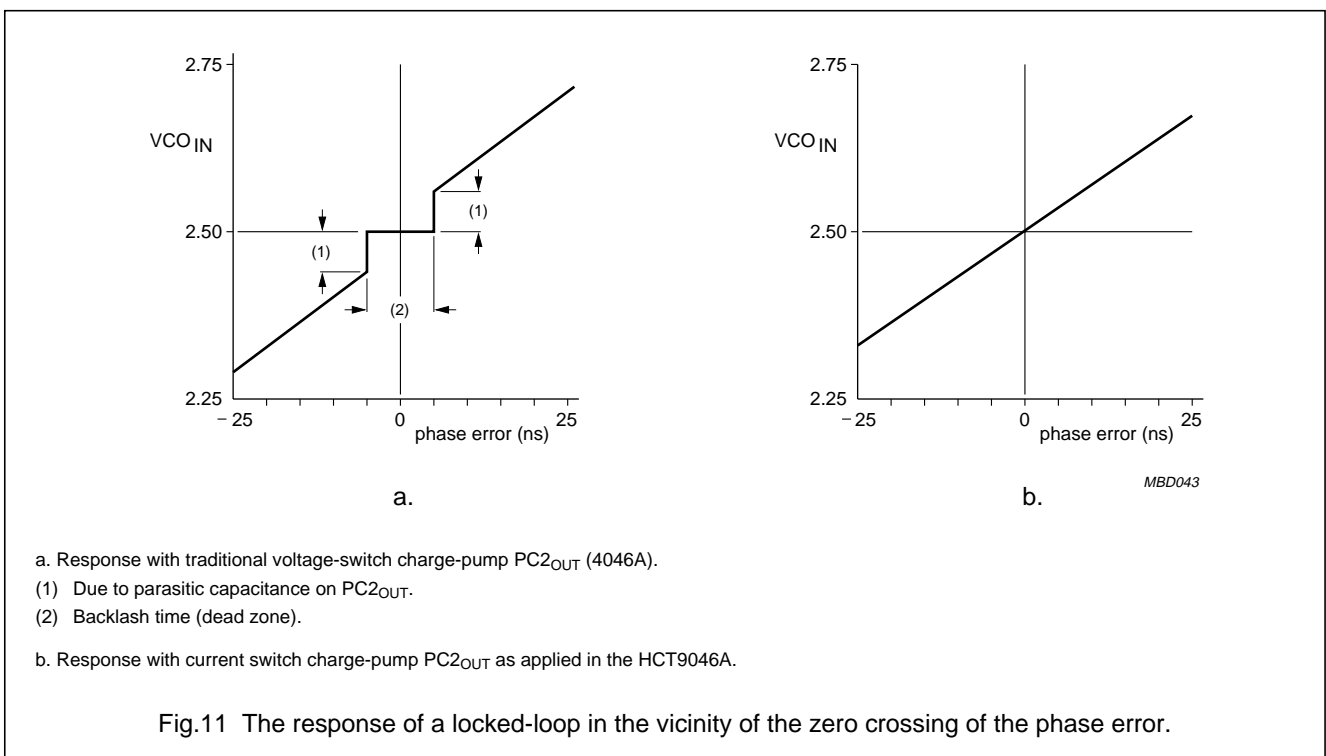
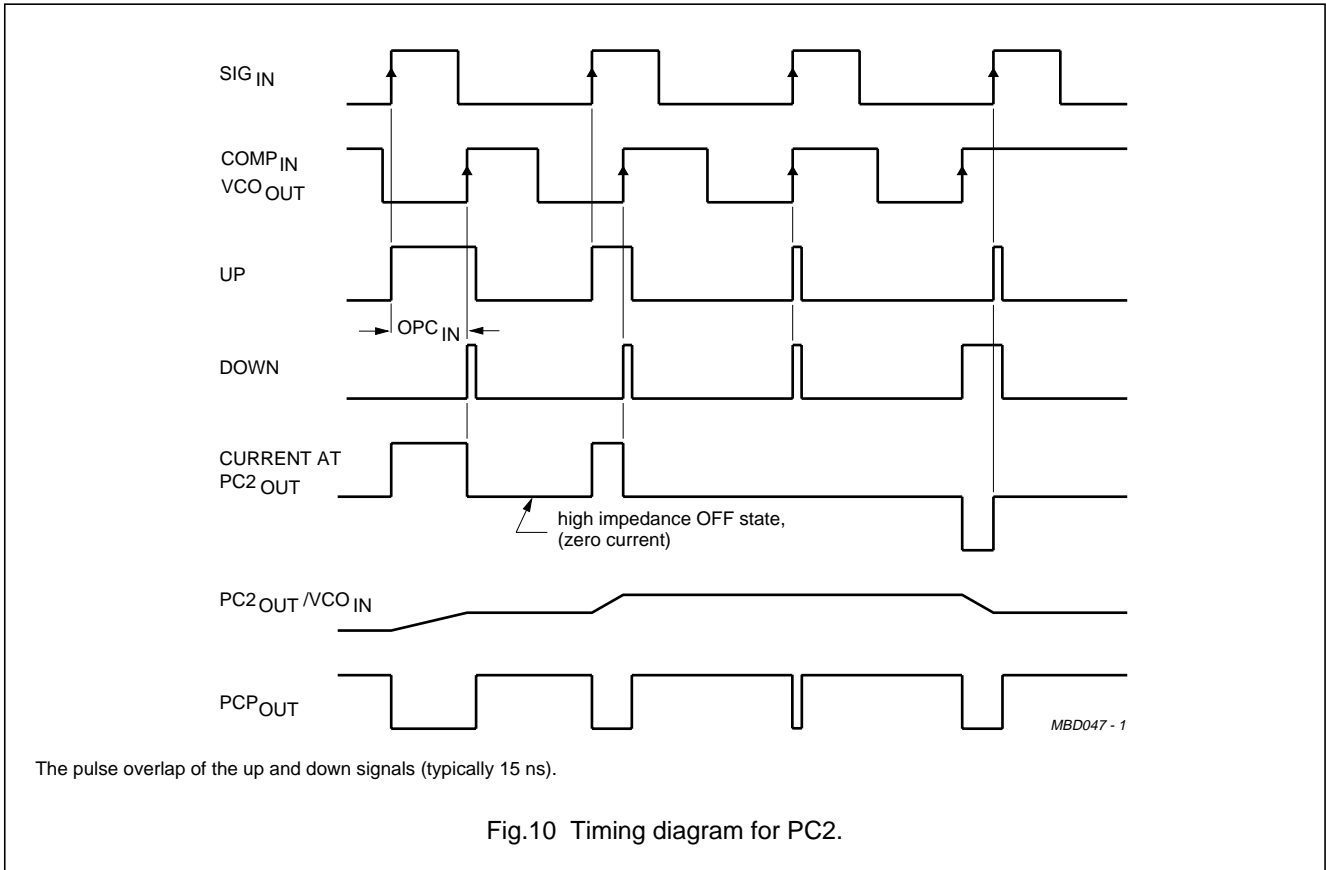
- a. The current transfer: pump current  $\frac{|I_P|}{2\pi} \Phi_{PCIN}$
- b. The voltage transfer; this transfer can be observed at PC2OUT by connecting a resistor ( $R = 10 \text{ k}\Omega$ ) between PC2OUT and  $\frac{1}{2}V_{CC}$ :

$$V_{DEMOUT} = V_{PC2OUT} = \frac{5}{4\pi} \Phi_{PCIN}$$

Fig.9 Phase comparator 2.

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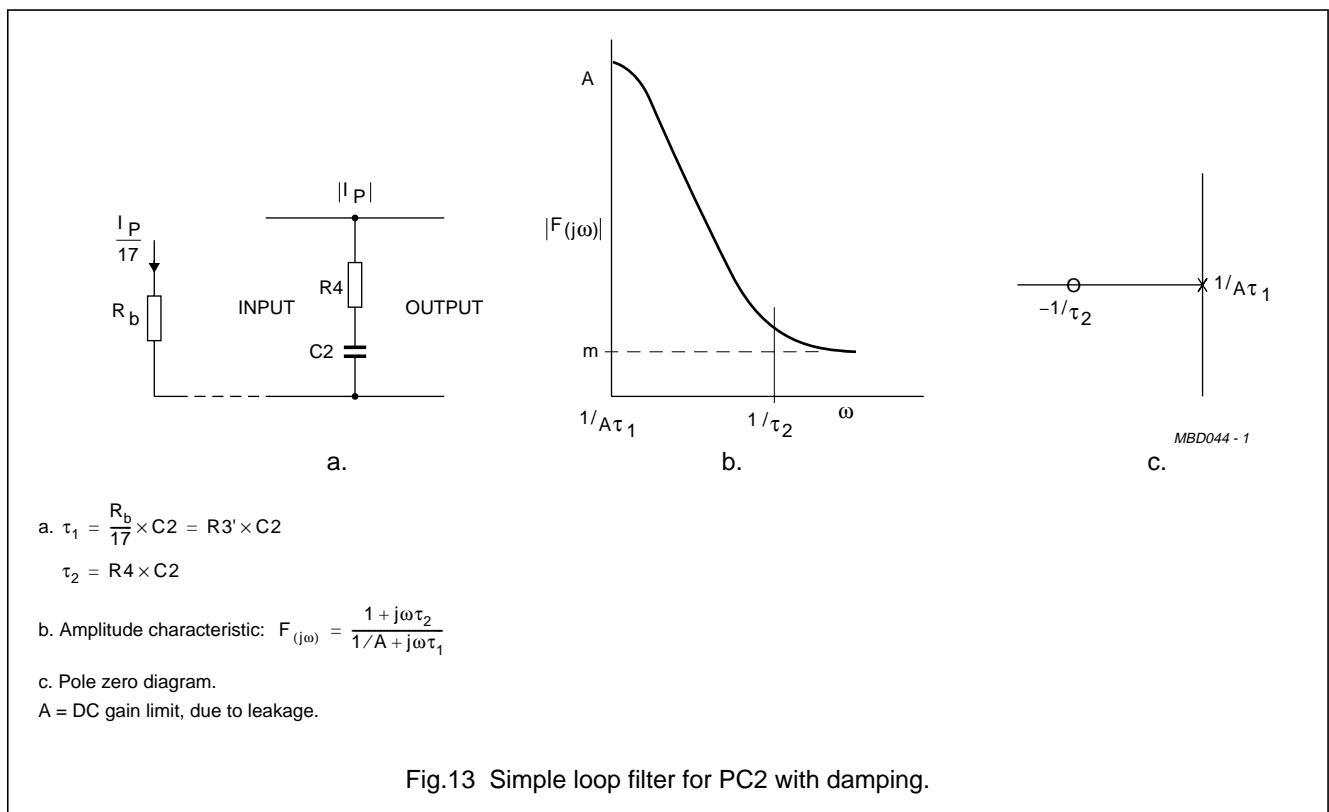
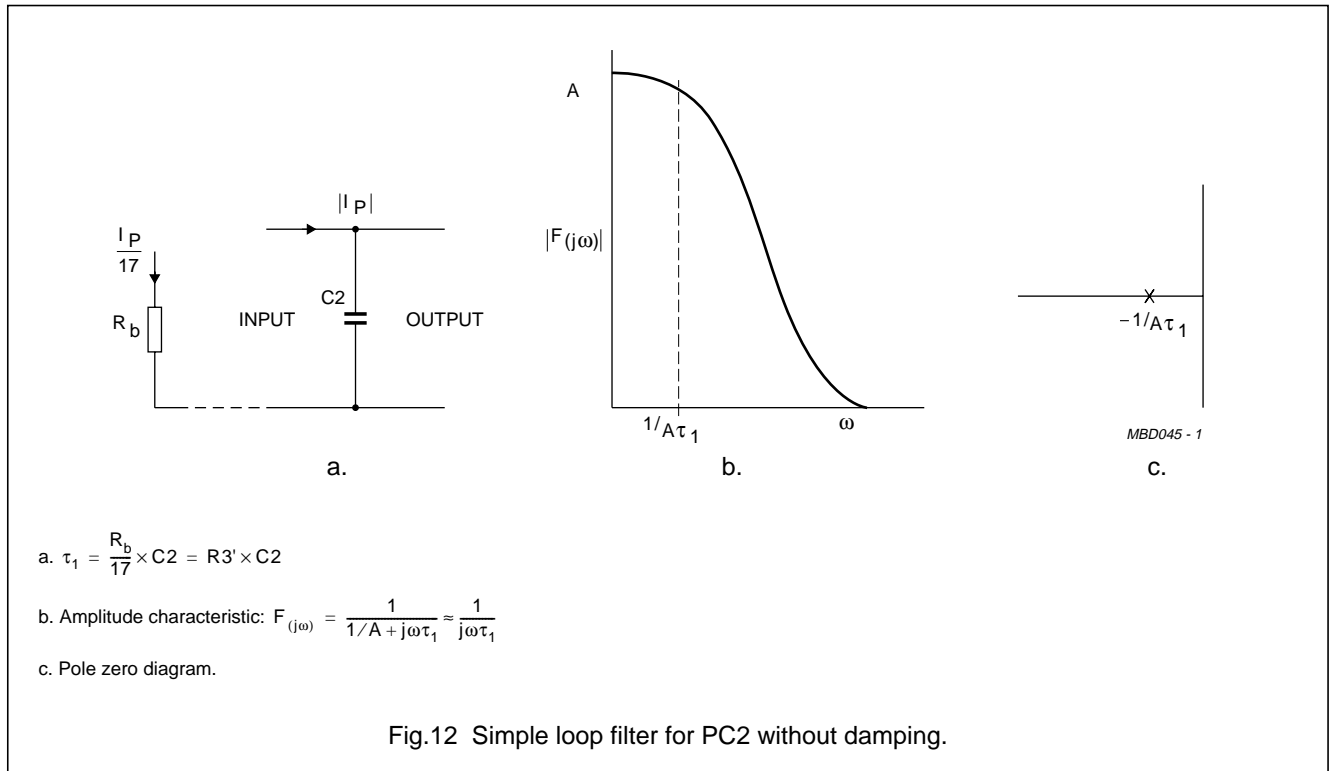
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LOOP FILTER COMPONENT SELECTION



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## RECOMMENDED OPERATING CONDITIONS FOR 74HCT

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{CC}$	DC supply voltage		4.5	5.0	5.5	V
$V_I$	DC input voltage		0	–	$V_{CC}$	V
$V_O$	DC output voltage		0	–	$V_{CC}$	V
$T_{amb}$	operating ambient temperature	see DC and AC Characteristics	–40	–	+85	°C
			–40	–	+125	°C
$t_r, t_f$	input rise and fall times (pin 5)	$V_{CC} = 4.5\text{ V}$	–	6	500	ns

## LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134); voltages are referenced to GND (ground = 0 V).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{CC}$	DC supply voltage		–0.5	+7	V
$I_{IK}$	DC input diode current	for $V_I < -0.5\text{ V}$ or $V_I > V_{CC} + 0.5\text{ V}$	–	±20	mA
$I_{OK}$	DC output diode current	for $V_O < -0.5\text{ V}$ or $V_O > V_{CC} + 0.5\text{ V}$	–	±20	mA
$I_O$	DC output source or sink current	for $-0.5\text{ V} < V_O < V_{CC} + 0.5\text{ V}$	–	±25	mA
$I_{CC}; I_{GND}$	DC $V_{CC}$ or GND current		–	±50	mA
$T_{stg}$	storage temperature		–65	+150	°C
$P_{tot}$	total power dissipation per package plastic DIL	note 1 above +70 °C: derate linearly with 12 mW/K	–	750	mW
	plastic mini-pack (SO)	above +70 °C: derate linearly with 8 mW/K	–	500	mW

## Note

1. Temperature range: –40 to +125 °C.

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## DC CHARACTERISTICS FOR 74HCT

Voltages are referenced to GND (ground = 0 V).

SYMBOL	PARAMETER	T <sub>amb</sub> (°C)							UNIT	TEST CONDITIONS		
		+25			-40 to +85		-40 to +125			V <sub>CC</sub> (V)	V <sub>I</sub> (V)	OTHER
		MIN.	TYP.	MAX.	MIN.	MAX.	MIN.	MAX.				
<b>Phase comparator section</b>												
V <sub>IH</sub>	DC coupled HIGH level input voltage SIG <sub>IN</sub> , COMP <sub>IN</sub>	3.15	2.4	–	3.15	–	3.15	–	V	4.5	–	
V <sub>IL</sub>	DC coupled LOW level input voltage SIG <sub>IN</sub> , COMP <sub>IN</sub>	–	2.1	1.35	–	1.35	–	1.35	V	4.5	–	
V <sub>OH</sub>	HIGH level output voltage PCP <sub>OUT</sub> , PCn <sub>OUT</sub>	4.4	4.5	–	4.4	–	4.4	–	V	4.5	V <sub>IH</sub> or V <sub>IL</sub>	I <sub>O</sub> = –20 µA
		3.98	4.32	–	3.84	–	3.7	–	V	4.5	V <sub>IH</sub> or V <sub>IL</sub>	I <sub>O</sub> = –4.0 mA
V <sub>OL</sub>	LOW level output voltage PCP <sub>OUT</sub> , PCn <sub>OUT</sub>	–	0	0.1	–	0.1	–	0.1	V	4.5	V <sub>IH</sub> or V <sub>IL</sub>	I <sub>O</sub> = –20 µA
		–	0.15	0.26	–	0.33	–	0.4	V	4.5	V <sub>IH</sub> or V <sub>IL</sub>	I <sub>O</sub> = –4.0 mA
I <sub>I</sub>	input leakage current SIG <sub>IN</sub> , COMP <sub>IN</sub>	–	–	±30	–	±38	–	±45	µA	5.5	V <sub>CC</sub> or GND	
I <sub>OZ</sub>	3-state OFF-state current PC2 <sub>OUT</sub>	–	–	±0.5	–	±5.0	–	±10.0	µA	5.5	V <sub>IH</sub> or V <sub>IL</sub>	V <sub>O</sub> = V <sub>CC</sub> or GND
R <sub>I</sub>	input resistance SIG <sub>IN</sub> , COMP <sub>IN</sub>	–	250	–	–	–	–	–	kΩ	4.5	V <sub>I</sub> at self-bias operating point; ΔV <sub>I</sub> = 0.5 V; see Figs 14 to 16	
R <sub>b</sub>	bias resistance	25	–	250	–	–	–	–	kΩ	4.5	–	
I <sub>P</sub>	charge pump current	±0.53	±1.06	±2.12	–	–	–	–	mA	4.5	–	R <sub>b</sub> = 40 kΩ

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SYMBOL	PARAMETER	T <sub>amb</sub> (°C)							UNIT	TEST CONDITIONS		
		+25			-40 to +85		-40 to +125			V <sub>CC</sub> (V)	V <sub>I</sub> (V)	OTHER
		MIN.	TYP.	MAX.	MIN.	MAX.	MIN.	MAX.				
<b>VCO section</b>												
V <sub>IH</sub>	DC coupled HIGH level input voltage INH	2.0	1.6	–	2.0	–	2.0	–	V	4.5 to 5.5	–	
V <sub>IL</sub>	DC coupled LOW level input voltage INH	–	1.2	0.8	–	0.8	–	0.8	V	4.5 to 5.5	–	
V <sub>OH</sub>	HIGH level output voltage VCO <sub>OUT</sub>	4.4	4.5	–	4.4	–	4.4	–	V	4.5	V <sub>IH</sub> or V <sub>IL</sub>	I <sub>O</sub> = –20 µA
		3.98	4.32	–	3.84	–	3.7	–	V	4.5	V <sub>IH</sub> or V <sub>IL</sub>	I <sub>O</sub> = –4.0 mA
V <sub>OL</sub>	LOW level output voltage VCO <sub>OUT</sub>	–	0	0.1	–	0.1	–	0.1	V	4.5	V <sub>IH</sub> or V <sub>IL</sub>	I <sub>O</sub> = 20 µA
		–	0.15	0.26	–	0.33	–	0.4	V	4.5	V <sub>IH</sub> or V <sub>IL</sub>	I <sub>O</sub> = 4.0 mA
V <sub>OL</sub>	LOW level output voltage C1 <sub>A</sub> , C1 <sub>B</sub>	–	–	0.40	–	0.47	–	0.54	V	4.5	V <sub>IH</sub> or V <sub>IL</sub>	I <sub>O</sub> = 4.0 mA
I <sub>I</sub>	input leakage current INH and VCO <sub>IN</sub>	–	–	±0.1	–	±1.0	–	±1.0	µA	5.5	V <sub>CC</sub> or GND	
R1	resistance	3	–	300	–	–	–	–	kΩ	4.5	–	
R2	resistance	3	–	300	–	–	–	–	kΩ	4.5	–	
C1	capacitance	40	–	no limit	–	–	–	–	pF	4.5	–	
V <sub>VCOIN</sub>	operating voltage range at VCO <sub>IN</sub>	1.1	–	3.4	–	–	–	–	V	4.5	–	over the range specified for R1
		1.1	–	3.9	–	–	–	–	V	5.0	–	
		1.1	–	4.4	–	–	–	–	V	5.5	–	

## PLL with bandgap controlled VCO

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SYMBOL	PARAMETER	T <sub>amb</sub> (°C)							UNIT	TEST CONDITIONS		
		+25			-40 to +85		-40 to +125			V <sub>CC</sub> (V)	V <sub>I</sub> (V)	OTHER
		MIN.	TYP.	MAX.	MIN.	MAX.	MIN.	MAX.				
<b>Demodulator section</b>												
R <sub>s</sub>	resistance	50	–	300	–	–	–	–	kΩ	4.5	–	at R <sub>s</sub> > 300 kΩ the leakage current can influence V <sub>DEMOUT</sub>
V <sub>OFF</sub>	offset voltage VCO <sub>IN</sub> to V <sub>DEMOUT</sub>	–	±20	–	–	–	–	–	mV	4.5	–	V <sub>I</sub> = V <sub>VCOIN</sub> = ½V <sub>CC</sub> ; values taken over R <sub>s</sub> range, see Fig.17
R <sub>D</sub>	dynamic output resistance at DEM <sub>OUT</sub>	–	25	–	–	–	–	–	Ω	4.5	–	V <sub>DEMOUT</sub> = ½V <sub>CC</sub>
<b>Quiescent supply current</b>												
I <sub>CC</sub>	quiescent supply current (disabled)	–	–	8.0	–	80.0	–	160.0	μA	5.5	–	pin 5 at V <sub>CC</sub>
ΔI <sub>CC</sub>	additional quiescent supply current per input pin for unit load coefficient is 1; note 1; V <sub>I</sub> = V <sub>CC</sub> – 2.1 V	–	100	360	–	450	–	490	μA	4.5	–	other inputs at V <sub>CC</sub> or GND

**Note**

- The value of additional quiescent supply current (ΔI<sub>CC</sub>) for a unit load of 1 is given above. To determine ΔI<sub>CC</sub> per input, multiply this value by the unit load coefficient shown in Table 1.

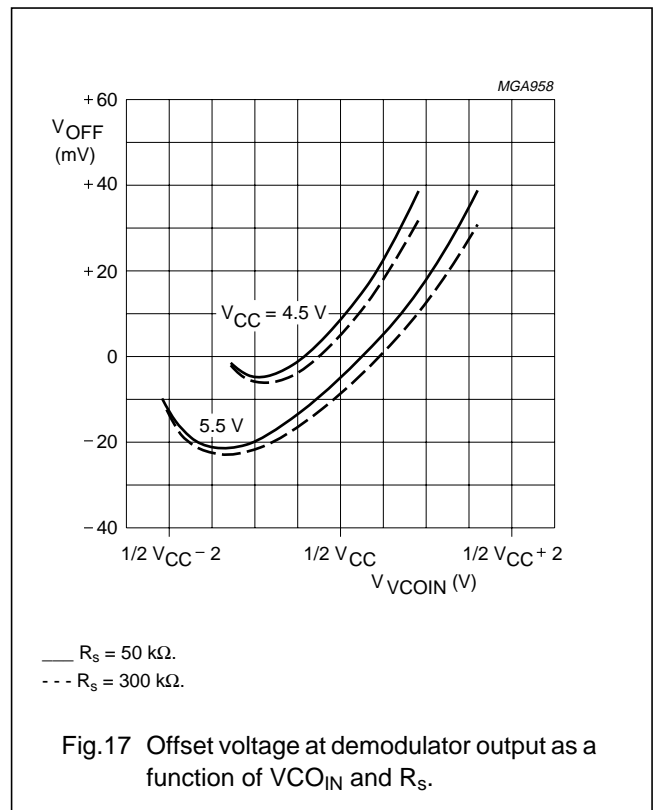
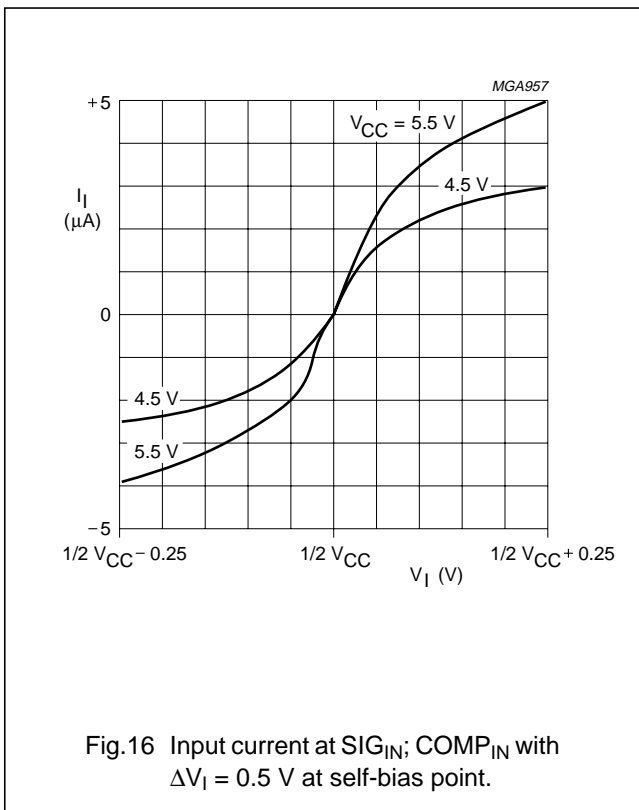
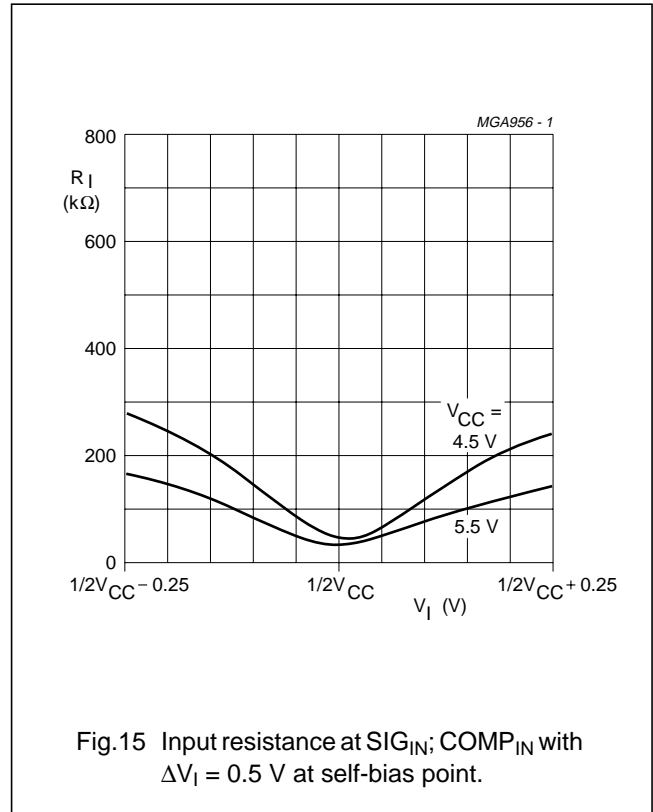
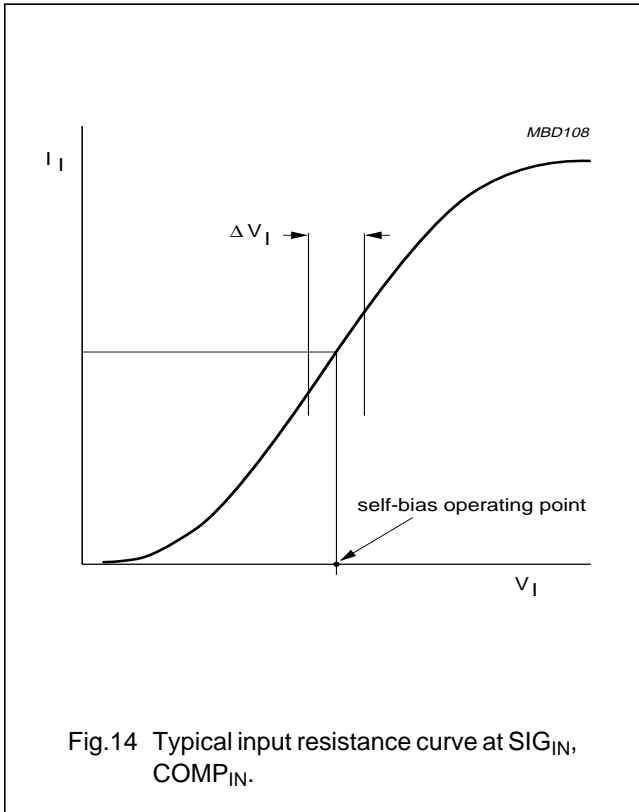
**Table 1** Unit load coefficient table.

INPUT	UNIT LOAD COEFFICIENT
INH	1.00



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## PLL with bandgap controlled VCO

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## AC CHARACTERISTICS FOR 74HCT

GND = 0 V;  $t_r = t_f = 6$  ns;  $C_L = 50$  pF.

SYMBOL	PARAMETER	$T_{amb}$ (°C)						UNIT	TEST CONDITION		
		+25			-40 to +85		-40 to +125		$V_{CC}$ (V)	WAVEFORMS	
		MIN.	TYP.	MAX.	MIN.	MAX.	MIN.				MAX.
<b>Phase comparator section</b>											
$t_{PHL}/t_{PLH}$	propagation delay SIG <sub>IN</sub> , COMP <sub>IN</sub> to PC1 <sub>OUT</sub>	–	23	40	–	50	–	60	ns	4.5	Fig.18
$t_{PHL}/t_{PLH}$	propagation delay SIG <sub>IN</sub> , COMP <sub>IN</sub> to PC2 <sub>OUT</sub>	–	35	68	–	85	–	102	ns	4.5	Fig.18
$t_{PZH}/t_{PZL}$	3–state output enable time SIG <sub>IN</sub> , COMP <sub>IN</sub> to PC2 <sub>OUT</sub>	–	30	56	–	70	–	84	ns	4.5	Fig.19
$t_{PHZ}/t_{PLZ}$	3–state output enable time SIG <sub>IN</sub> , COMP <sub>IN</sub> to PC2 <sub>OUT</sub>	–	36	65	–	81	–	98	ns	4.5	Fig.19
$t_{THL}/t_{TLH}$	output transition time	–	7	15	–	19	–	22	ns	4.5	Fig.18
$V_{i(p-p)}$	AC coupled input sensitivity (peak-to-peak value) at SIG <sub>IN</sub> or COMP <sub>IN</sub>	–	15	–	–	–	–	–	mV	4.5	$f_i = 1$ MHz

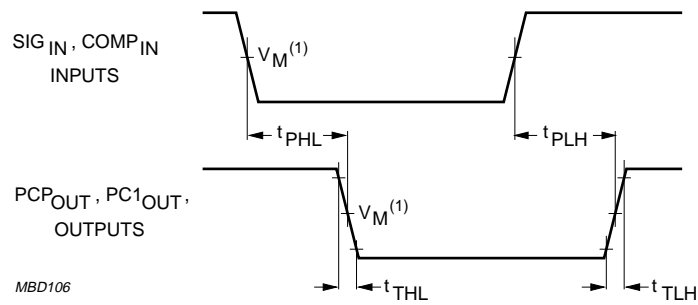
## PLL with bandgap controlled VCO

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SYMBOL	PARAMETER	T <sub>amb</sub> (°C)							UNIT	TEST CONDITION	
		+25			-40 to +85		-40 to +125			V <sub>CC</sub> (V)	WAVEFORMS
		MIN.	TYP.	MAX.	MIN.	MAX.	MIN.	MAX.			
<b>VCO section</b>											
$\Delta f/T$	frequency stability with temperature change	–	–	–	0.06	–	–	–	%/K	4.5	V <sub>VCOIN</sub> = 1/2 V <sub>CC</sub> ; recommended range: R1 = 10 k $\Omega$ ; R2 = 10 k $\Omega$ ; C1 = 1 nF; Figs 20 to 22
$\Delta f_c$	centre frequency tolerance	–10	–	+10	–	–	–	–	%	5.0	V <sub>VCOIN</sub> = 3.9 V; R1 = 10 k $\Omega$ ; R2 = 10 k $\Omega$ ; C1 = 1 nF
f <sub>c</sub>	VCO centre frequency (duty factor = 50%)	11.0	15.0	–	–	–	–	–	MHz	4.5	V <sub>VCOIN</sub> = 1/2 V <sub>CC</sub> ; R1 = 4.3 k $\Omega$ ; R2 = $\infty$ ; C1 = 40 pF; Figs 23 and 31
$\Delta f_{VCO}$	VCO frequency linearity	–	0.4	–	–	–	–	–	%	4.5	R1 = 100 k $\Omega$ ; R2 = $\infty$ ; C1 = 100 pF; Figs 24 and 25
$\delta_{VCO}$	duty factor at VCO <sub>OUT</sub>	–	50	–	–	–	–	–	%	4.5	

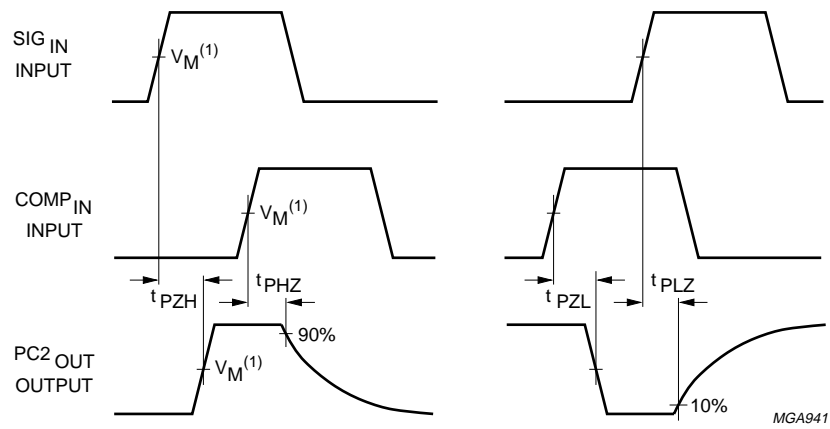
PLL with bandgap controlled VCO

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(1)  $V_M = \frac{1}{2}V_{CC}$ ;  $V_I = \text{GND to } V_{CC}$ .

Fig.18 Waveforms showing input (SIG<sub>IN</sub> and COMP<sub>IN</sub>) to output (PCP<sub>OUT</sub> and PC1<sub>OUT</sub>) propagation delays and the output transition times.

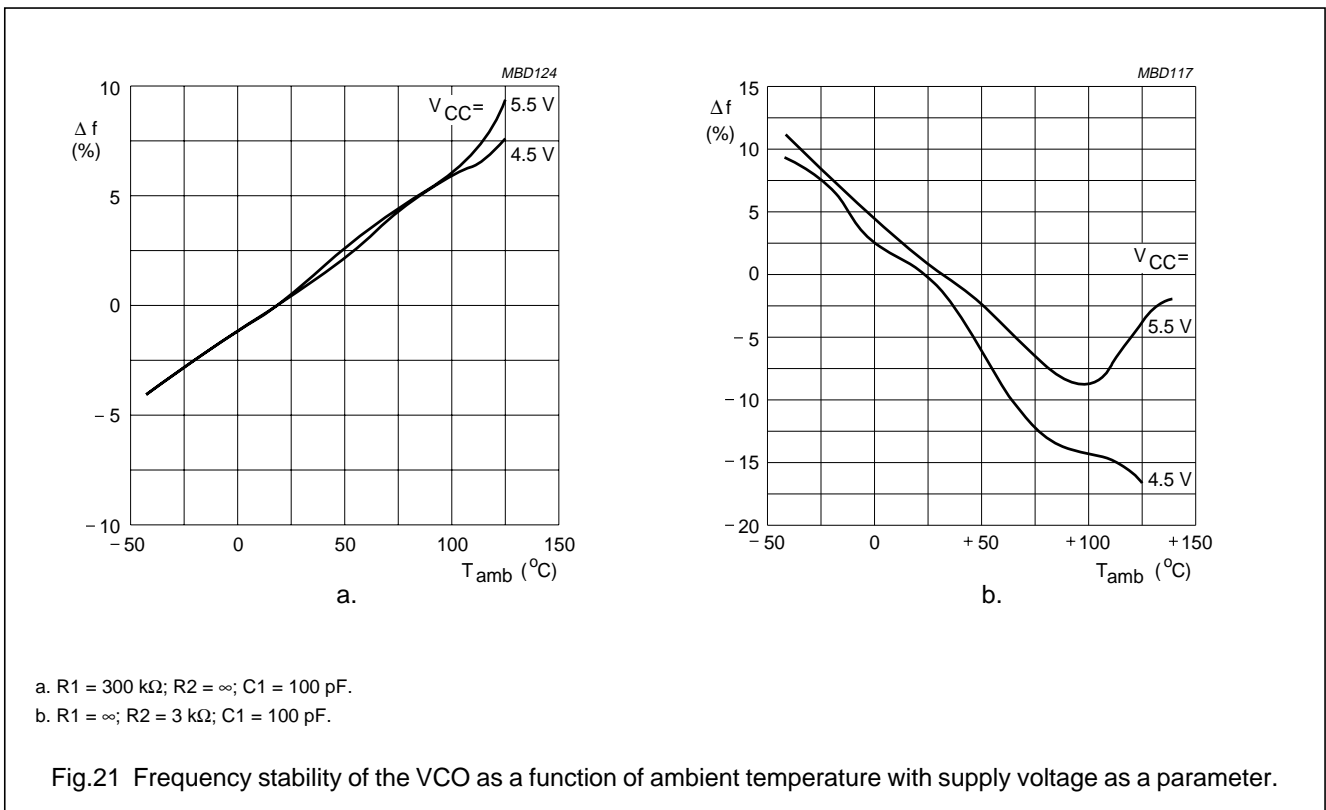
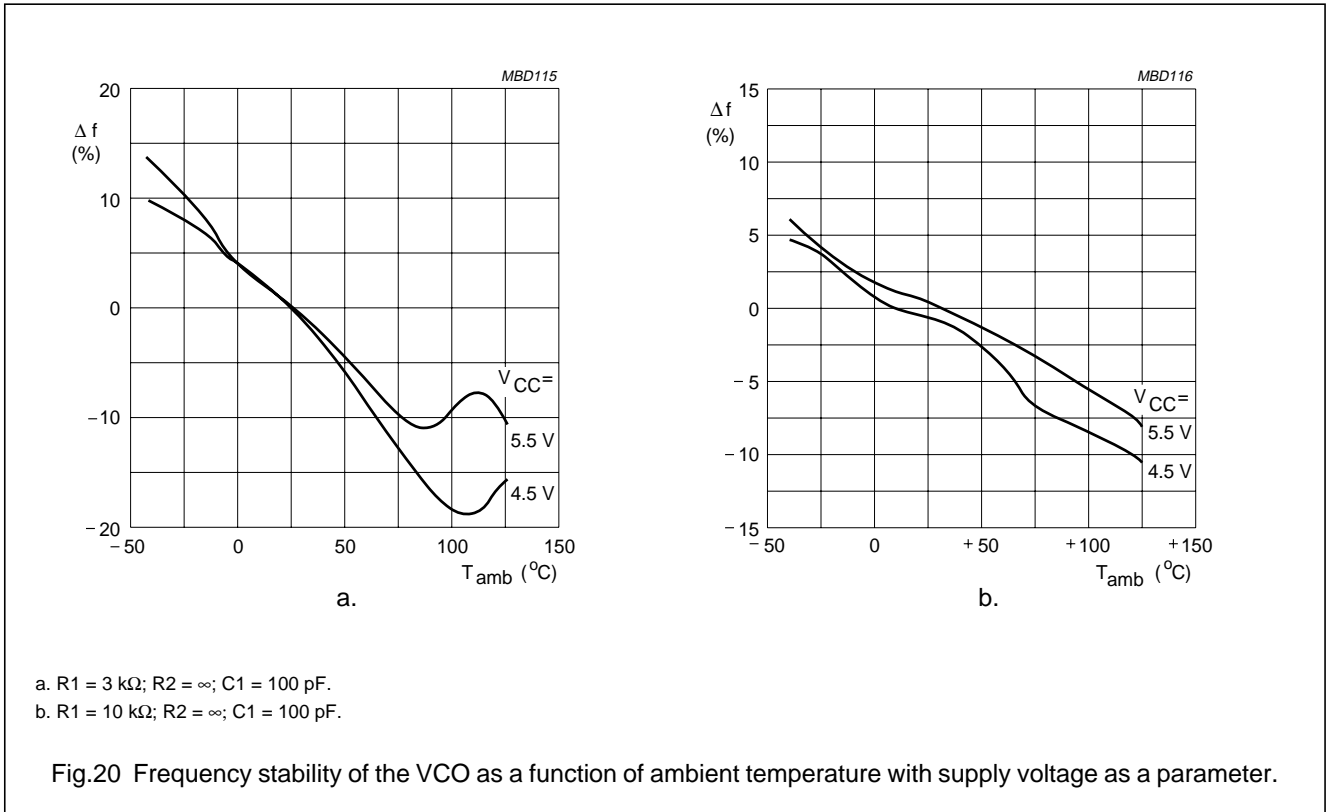


(1)  $V_M = \frac{1}{2}V_{CC}$ ;  $V_I = \text{GND to } V_{CC}$ .

Fig.19 Waveforms showing the 3-state enable and disable times for PC2<sub>OUT</sub>.

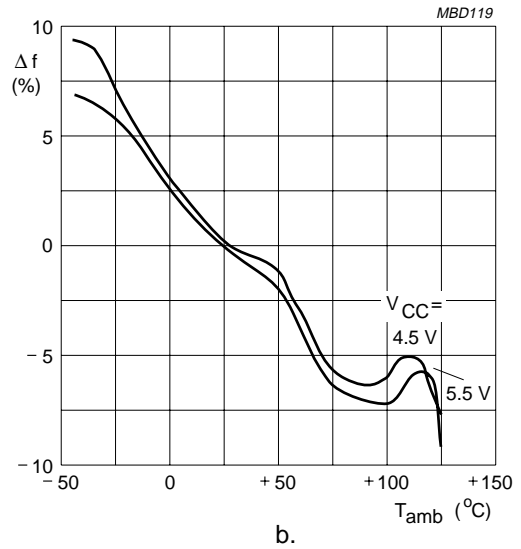
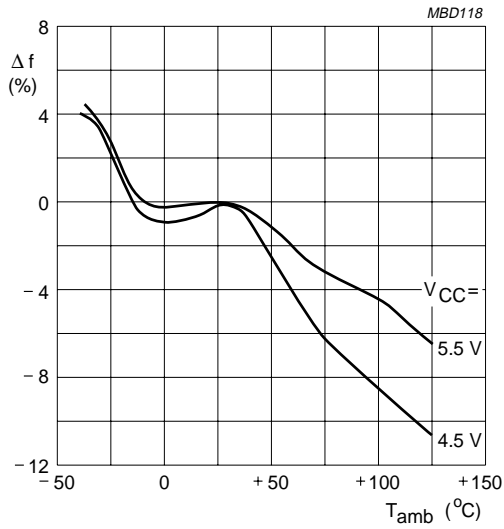
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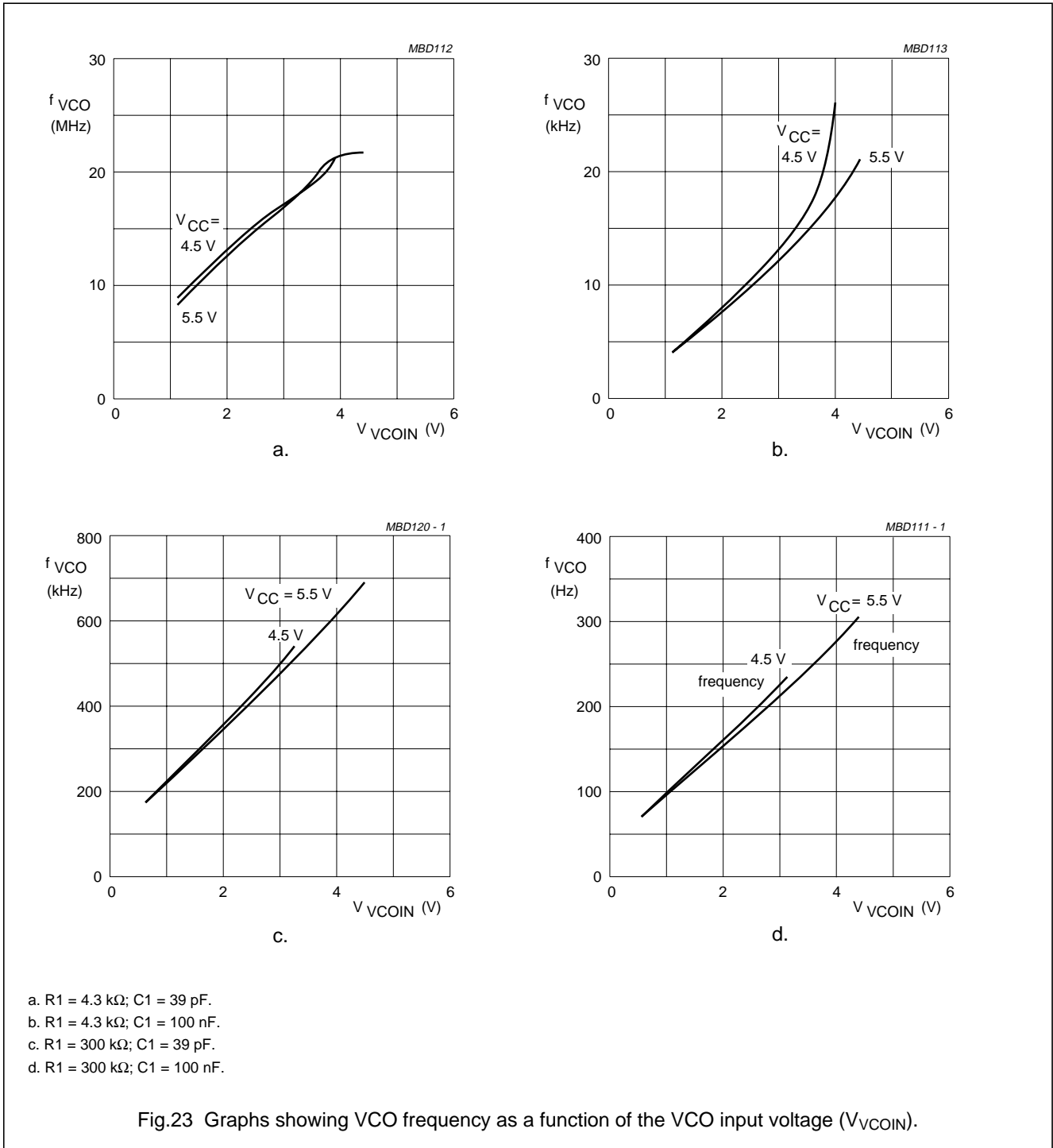


- a.  $R1 = \infty$ ;  $R2 = 10 \text{ k}\Omega$ ;  $C1 = 100 \text{ pF}$ .
- b.  $R1 = \infty$ ;  $R2 = 300 \text{ k}\Omega$ ;  $C1 = 100 \text{ pF}$ .

Fig.22 Frequency stability of the VCO as a function of ambient temperature with supply voltage as a parameter.

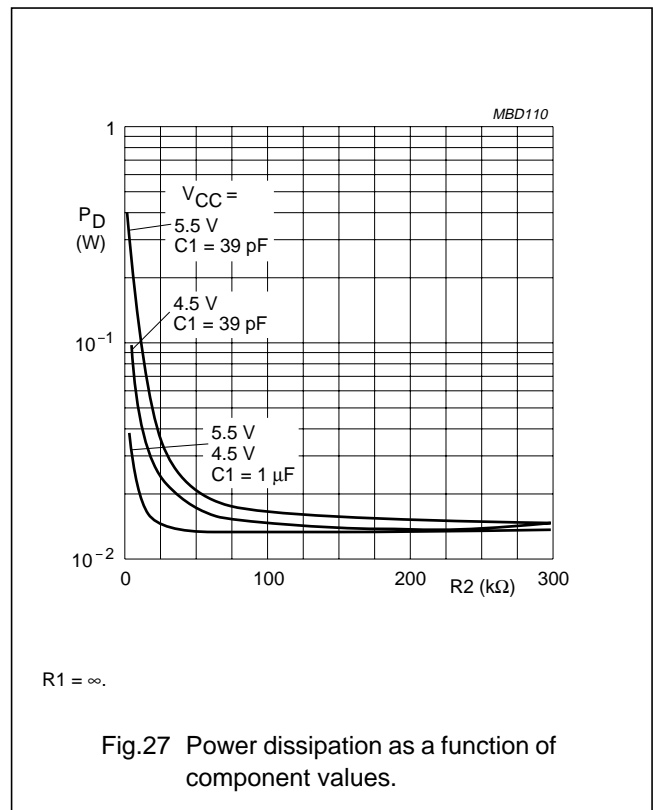
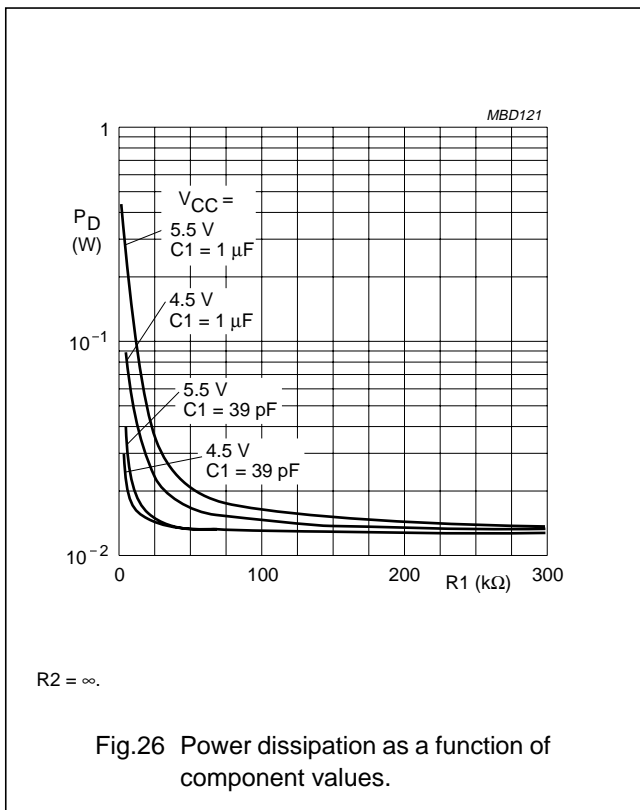
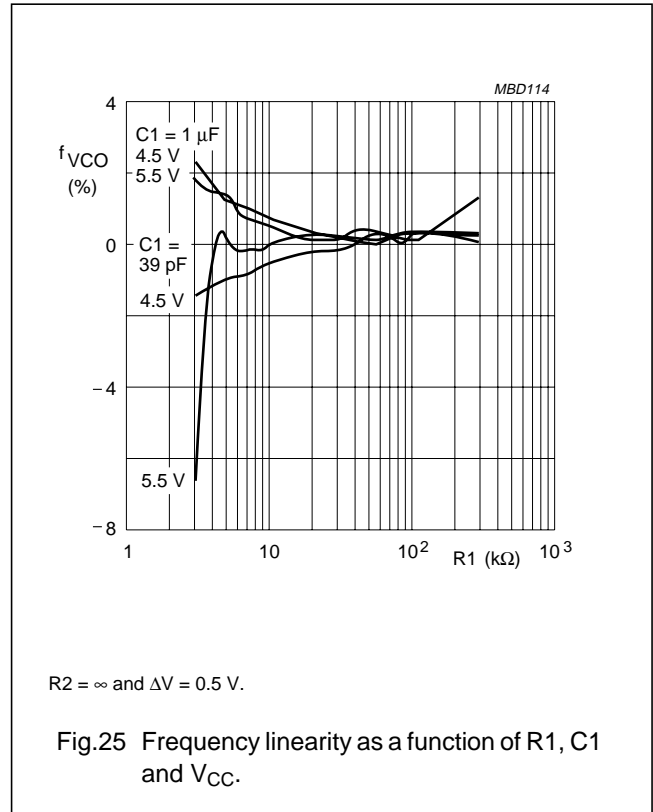
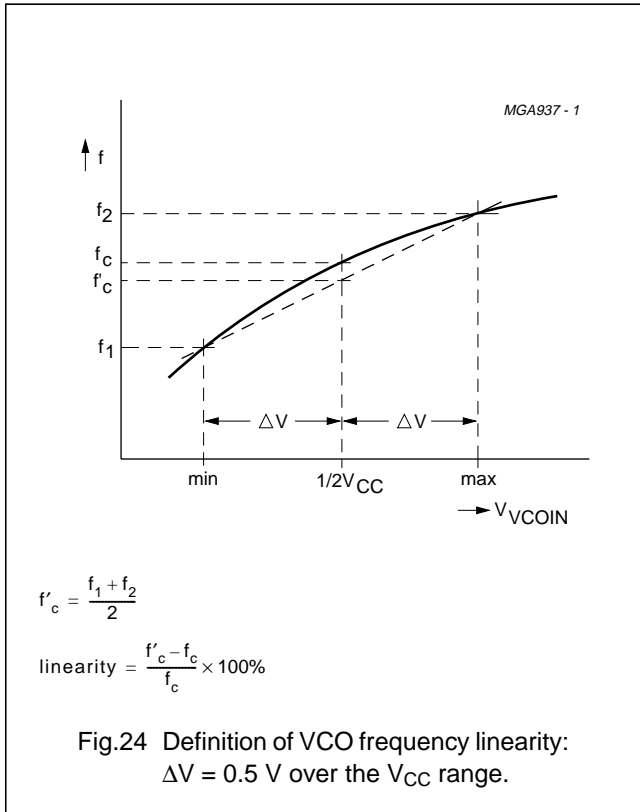
PLL with bandgap controlled VCO

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PLL with bandgap controlled VCO

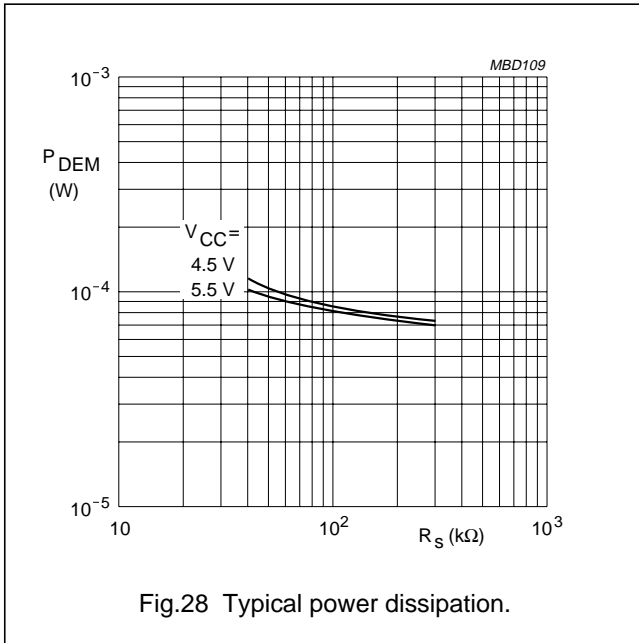
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PLL with bandgap controlled VCO

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APPLICATION INFORMATION

This information is a guide for the approximation of values of external components to be used with the 74HCT9046A in a phase-locked-loop system.

Values of the selected components should be within the ranges shown in Table 2.

Table 2 Survey of components.

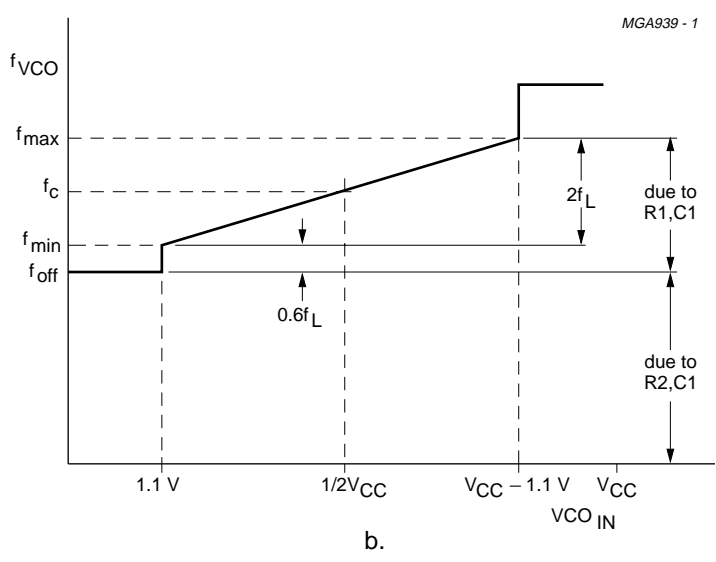
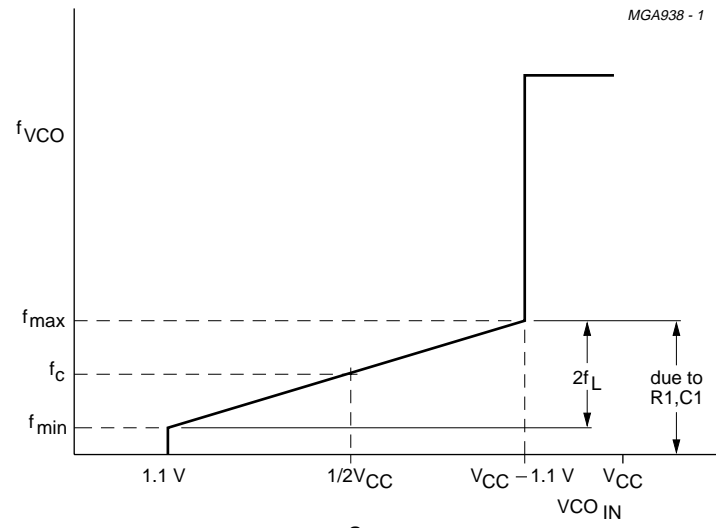
COMPONENT	VALUE
R1	between 3 kΩ and 300 kΩ
R2	between 3 kΩ and 300 kΩ
R1 + R2	parallel value >2.7 kΩ
C1	>40 pF

Table 3 Design considerations for VCO section.

SUBJECT	PHASE COMPARATOR	DESIGN CONSIDERATION
VCO frequency <b>without extra offset</b>	PC1, PC2	<b>VCO frequency characteristic</b> With $R2 = \infty$ and $R1$ within the range $3\text{ k}\Omega < R1 < 300\text{ k}\Omega$ , the characteristics of the VCO operation will be as shown in Fig.29a. (Due to $R1$ , $C1$ time constant a small offset remains when $R2 = \infty$ ).
	PC1	<b>Selection of R1 and C1</b> Given $f_c$ , determine the values of $R1$ and $C1$ using Fig.31.
	PC2	Given $f_{max}$ and $f_c$ determine the values of $R1$ and $C1$ using Fig.31; use Fig.33 to obtain $2f_L$ and then use this to calculate $f_{min}$ .
VCO frequency <b>with extra offset</b>	PC1, PC2	<b>VCO frequency characteristic</b> With $R1$ and $R2$ within the ranges $3\text{ k}\Omega < R1 < 300\text{ k}\Omega < R2 < 300\text{ k}\Omega$ , the characteristics of the VCO operation is as shown in Fig.29b.
	PC1, PC2	<b>Selection of R1, R2 and C1</b> Given $f_c$ and $f_L$ determine the value of product $R1C1$ by using Fig.33. Calculate $f_{off}$ from the equation $f_{off} = f_c - 1.6f_L$ . Obtain the values of $C1$ and $R2$ by using Fig.32. Calculate the value of $R1$ from the value of $C1$ and the product $R1C1$ .
PLL conditions with no signal at the SIG <sub>IN</sub> input	PC1	VCO adjusts to $f_c$ with $\Phi_{PCIN} = 90^\circ$ and $V_{VCOIN} = \frac{1}{2}V_{CC}$ .
	PC2	VCO adjusts to $f_{offset}$ with $\Phi_{PCIN} = -360^\circ$ and $V_{VCOIN} = \text{minimum}$ .

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- a. Operating without offset;  $f_c$  = centre frequency;  $2f_L$  = frequency lock range.
- b. Operating with offset;  $f_c$  = centre frequency;  $2f_L$  = frequency lock range.

Fig.29 Frequency characteristic of VCO.

## PLL with bandgap controlled VCO

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**Filter design considerations for PC1 and PC2 of the HCT9046A**

Figure 30 shows some examples of passive and active filters to be used with the phase comparators of the HCT9046A. Transfer functions of phase comparators and filters are given in Table 4.

**Table 4** Transfer functions of phase comparators and filters.

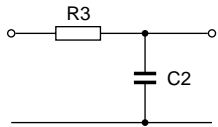
PHASE COMPARATOR	Fig.30	FILTER TYPE	TRANSFER FUNCTION	EXPLANATION
PC1	a.	passive filter without damping	$F_{(j\omega)} = \frac{1}{1 + j\omega\tau_1}$	$K_{PC1} = \frac{V_{CC}}{\pi} V/r$ $\tau_1 = R3 \times C2;$ $\tau_2 = R4 \times C2;$ $\tau_3 = R4 \times C3;$ $A = 10^5 = \text{DC gain amplitude}$
	b.	passive filter with damping	$F_{(j\omega)} = \frac{1 + j\omega\tau_2}{1 + j\omega(\tau_1 + \tau_2)}$	
	c.	active filter with damping	$F_{(j\omega)} = \frac{1 + j\omega\tau_2}{1/A + j\omega\tau_1} \approx \frac{1 + j\omega\tau_2}{j\omega\tau_1}$	
PC2	d.	passive filter with damping	$F_{(j\omega)} = \frac{1 + j\omega\tau_2}{1/A + j\omega\tau_1} \approx \frac{1 + j\omega\tau_2}{j\omega\tau_1}$ $A = 10^5 = \text{limit DC gain}$	$K_{PC2} = \frac{5}{4\pi} V/r$ $\tau_1 = R3' \times C2;$ $\tau_2 = R4 \times C2;$ $\tau_3 = R4 \times C3;$ $R3' = R_b/17;$ $R_b = 25 \text{ to } 250 \text{ k}\Omega$
	e.	active filter with damping	$F_{(j\omega)} = \frac{1 + j\omega\tau_2}{1/A + j\omega\tau_1} \approx \frac{1 + j\omega\tau_2}{j\omega\tau_1}$ $A = 10^5 = \text{DC gain amplitude}$	

PLL with bandgap controlled VCO

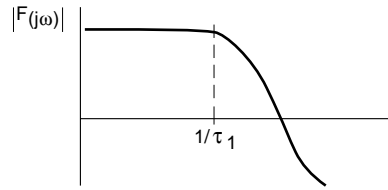
74HCT9046A

PC1

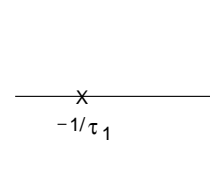
CIRCUIT



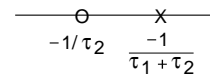
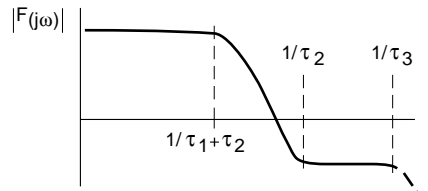
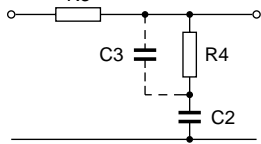
AMPLITUDE CHARACTERISTIC



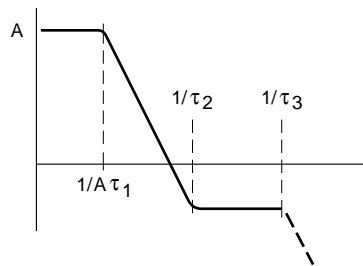
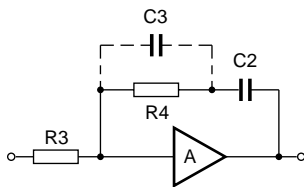
POLE ZERO DIAGRAM



a.

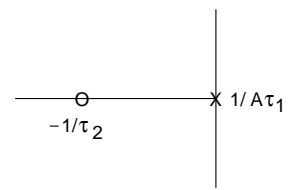
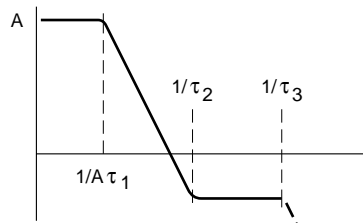
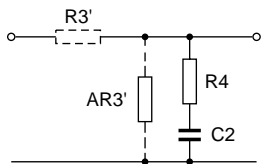


b.

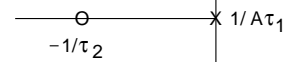
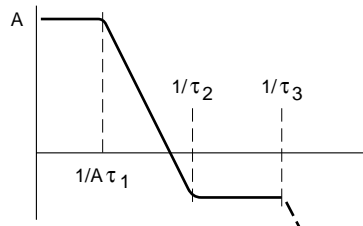
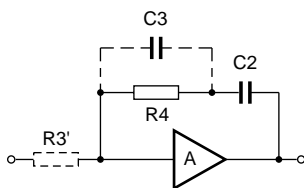


c.

PC2



d.



e.

MBD107-1

Fig.30 Passive and active filters for HCT9046A.

## PLL with bandgap controlled VCO

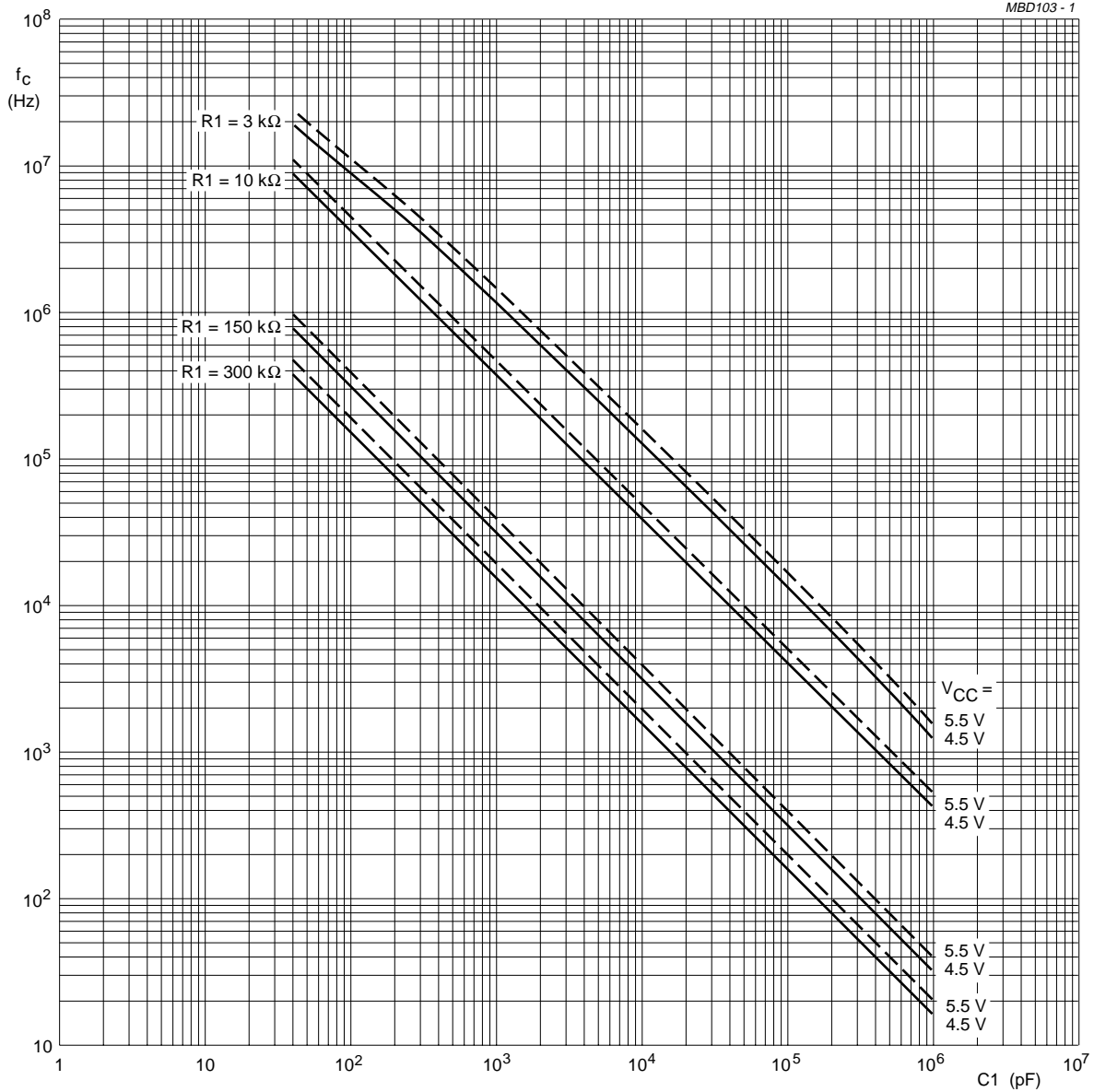
74HCT9046A

**General design consideration.**

<b>SUBJECT</b>	<b>PHASE COMPARATOR</b>	<b>DESIGN CONSIDERATION</b>
PLL locks on harmonics at centre frequency	PC1	yes
	PC2	no
Noise rejection at signal input	PC1	high
	PC2	low
AC ripple content when PLL is locked	PC1	$f_r = 2f_i$ ; large ripple content at $\Phi_{PCIN} = 90^\circ$
	PC2	$f_r = f_i$ ; small ripple content at $\Phi_{PCIN} = 0^\circ$

PLL with bandgap controlled VCO

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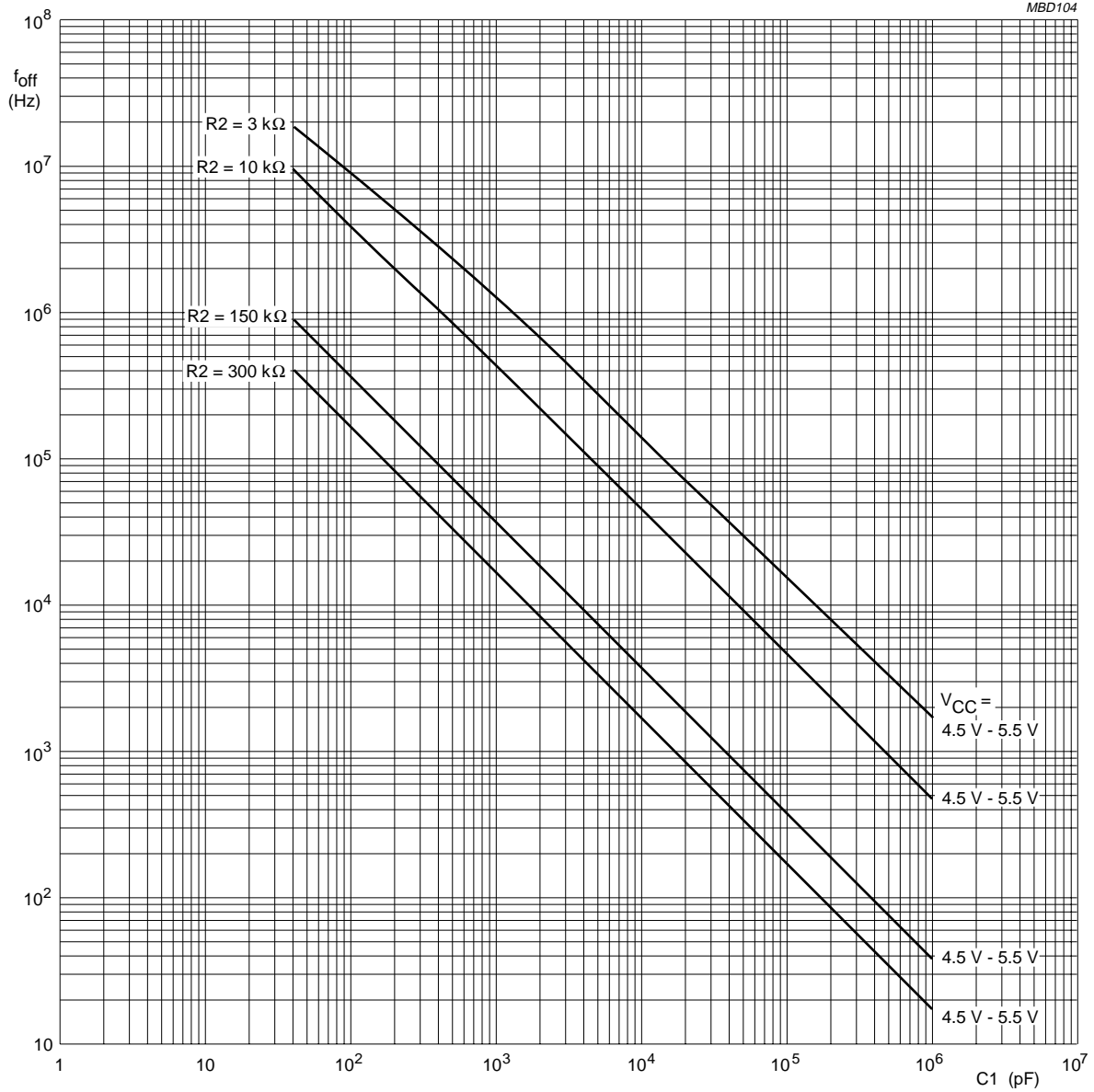


$R_2 = \infty$ ;  $V_{VCOIN} = \frac{1}{2}V_{CC}$ ;  $INH = GND$ ;  $T_{amb} = 25\text{ }^\circ\text{C}$ .

Fig.31 Typical value of VCO centre frequency ( $f_c$ ) as a function of  $C_1$ .

PLL with bandgap controlled VCO

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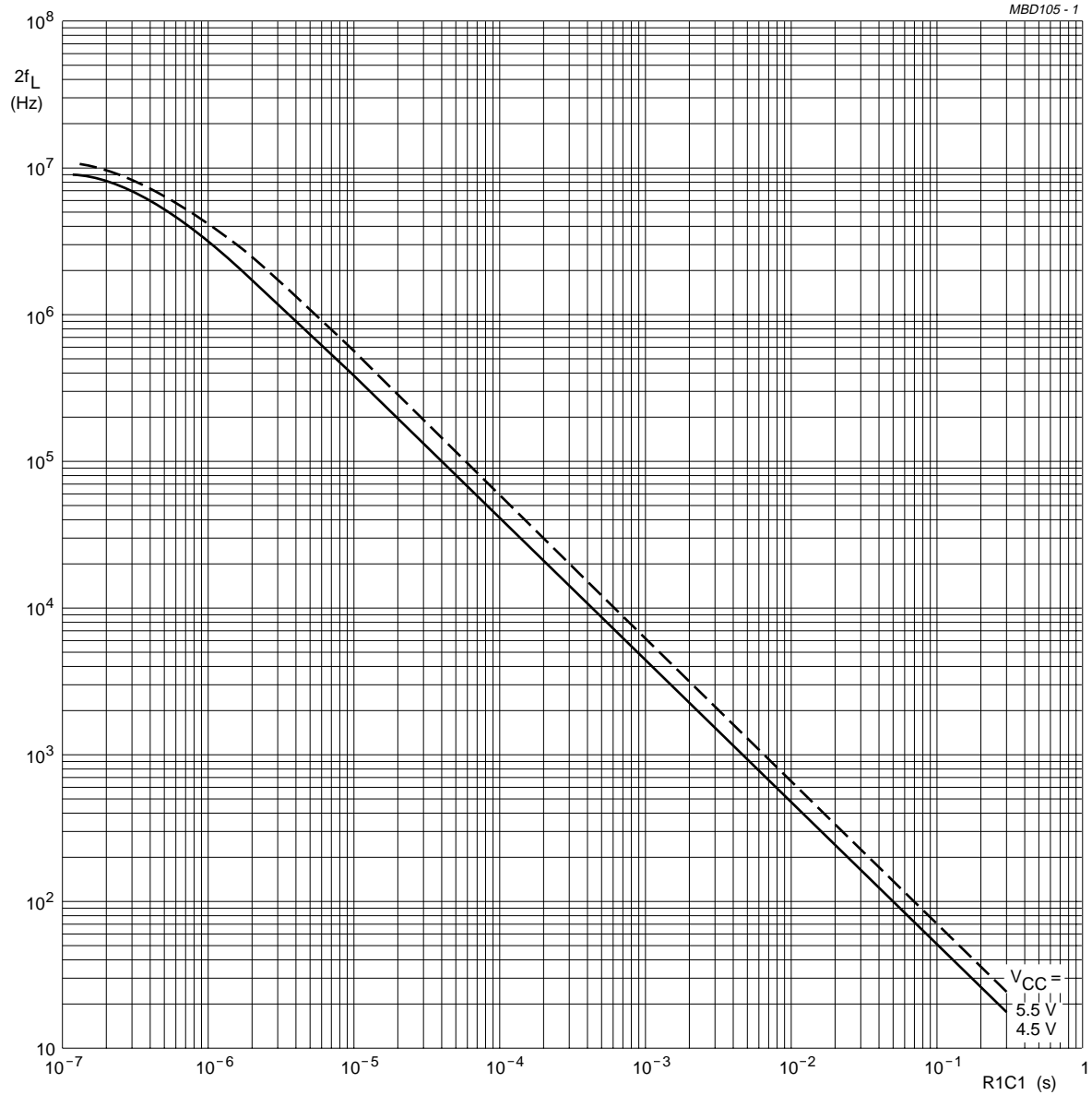


$R_1 = \infty$ ;  $V_{VCOIN} = \frac{1}{2}V_{CC}$ ;  $INH = GND$ ;  $T_{amb} = 25\text{ }^\circ\text{C}$ .

Fig.32 Typical value of frequency offset as a function of  $C_1$ .

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$$K_v = \frac{2f_L}{V_{VCOIN\ range}} 2\pi (r/s/V)$$

$V_{VCOIN} = 1.1 \text{ to } (V_{CC} - 1.1) \text{ V.}$

Fig.33 Typical frequency lock range  $2f_L$  as a function of the product  $R1$  and  $C1$ .



## PLL with bandgap controlled VCO

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**PLL design example**

The frequency synthesizer used in the design example shown in Fig.34 has the following parameters:

Output frequency: 2 MHz to 3 MHz.

Frequency steps: 100 kHz.

Settling time: 1 ms.

Overshoot: <20%.

The open loop gain is:

$$H(s) \times G(s) = K_p \times K_f \times K_o \times K_n$$

and the closed loop:

$$\frac{\Phi_u}{\Phi} = \frac{K_p \times K_f \times K_o \times K_n}{1 + K_p \times K_f \times K_o \times K_n}$$

where:

$K_p$  = phase comparator gain

$K_f$  = low-pass filter transfer gain

$K_o$  =  $K_v/s$  VCO gain

$K_n$  =  $1/n$  divider ratio.

The programmable counter ratio  $K_n$  can be found as follows:

$$N_{\min} = \frac{f_{\text{OUT}}}{f_{\text{step}}} = \frac{2 \text{ MHz}}{100 \text{ kHz}} = 20$$

$$N_{\max} = \frac{f_{\text{OUT}}}{f_{\text{step}}} = \frac{3 \text{ MHz}}{100 \text{ kHz}} = 30$$

The VCO is set by the values of R1, R2 and C1; R2 = 10 k $\Omega$  (adjustable).

The values can be determined using the information in Table 3.

With  $f_c = 2.5$  MHz and  $f_L = 500$  kHz this gives the following values ( $V_{CC} = 5.0$  V):

$$R1 = 30 \text{ k}\Omega.$$

$$R2 = 30 \text{ k}\Omega.$$

$$C1 = 100 \text{ pF}.$$

The VCO gain is:

$$K_v = \frac{2f_L \times 2\pi}{(V_{CC} - 1.1) - 1.1} =$$

$$\frac{1 \text{ MHz}}{2.8} \times 2\pi \approx 2.24 \times 10^6 \text{ r/s/V}$$

The gain of the phase comparator PC2 is:

$$K_p = \frac{5}{4 \times \pi} = 0.4 \text{ V/r}$$

Using PC2 with the passive filter as shown in Fig.34 results in a high gain loop with the same performance as a loop with an active filter. Hence loop filter equations as for a high gain loop should be used. The current source output of PC2 can be simulated then with a fictive filter resistance:

$$R3' = \frac{R_b}{17}$$

The transfer functions of the filter is given by:

$$K_f = \frac{1 + s\tau_2}{s\tau_2}$$

Where:

$$\tau_1 = R3' \times C2.$$

$$\tau_2 = R4 \times C2.$$

The characteristic equation is:

$$1 + K_p \times K_f \times K_o \times K_n$$

This results in:

$$1 + K_p \left( \frac{1 + s\tau_2}{s\tau_2} \right) \frac{K_v}{s} K_n = 0$$

or:

$$s^2 + sK_p K_v K_n \frac{\tau_2}{\tau_1} + K_p K_v K_n / \tau_1 = 0$$

This can be written as:

$$s^2 + 2\zeta\omega_n s + (\omega_n)^2 = 0$$

with the natural frequency  $\omega_n$  defined

$$\text{as: } \omega_n = \sqrt{\frac{K_p \times K_v \times K_n}{\tau_1}} \text{ and the}$$

damping value given as:

$$\zeta = 0.5 \times \tau_2 \times \omega_n$$

In Fig.35 the output frequency response to a step of input frequency is shown.

The overshoot and settling time percentages are now used to determine  $\omega_n$ . From Fig.35 it can be

seen that the damping ratio  $\zeta = 0.707$  will produce an overshoot of less than 20% and settle to within 5% at  $\omega_n t = 5$ . The required settling time is 1 ms. This results in:

$$\omega_n = \frac{5}{t} = \frac{5}{0.001} = 5 \times 10^3 \text{ r/s}$$

Rewriting the equation for natural frequency results in:

$$\tau_1 = \frac{K_p \times K_v \times K_n}{(\omega_n)^2}$$

The maximum overshoot occurs at  $N_{\max} = 30$ ; hence  $K_n = 1/30$ :

$$\tau_1 = \frac{0.4 \times 2.24 \times 10^6}{5000^2 \times 30} = 0.0012$$

When C2 = 470 nF, it follows:

$$R3' = \frac{\tau_1}{C2} = \frac{0.0012}{470 \times 10^{-9}} = 2550$$

Hence the current source bias resistance  $R_b = 17 \times 2550 = 43 \text{ k}\Omega$ .

With  $\zeta = 0.707$  ( $0.5 \times \tau_2 \times \omega_n$ ) it follows:

$$\tau_2 = \frac{0.707}{0.5 \times 5000} = 0.00028$$

$$R4 = \frac{\tau_2}{C2} = \frac{0.00028}{470 \times 10^{-9}} = 600 \Omega$$

For extra ripple suppression a capacitor C3 can be connected in parallel with R4, with an extra  $\tau_3 = R4 \times C3$ .

For stability reasons  $\tau_3$  should be  $< 0.1\tau_2$ , hence  $C3 < 0.1C2$ , or  $C3 = 39 \text{ nF}$ .

PLL with bandgap controlled VCO

74HCT9046A

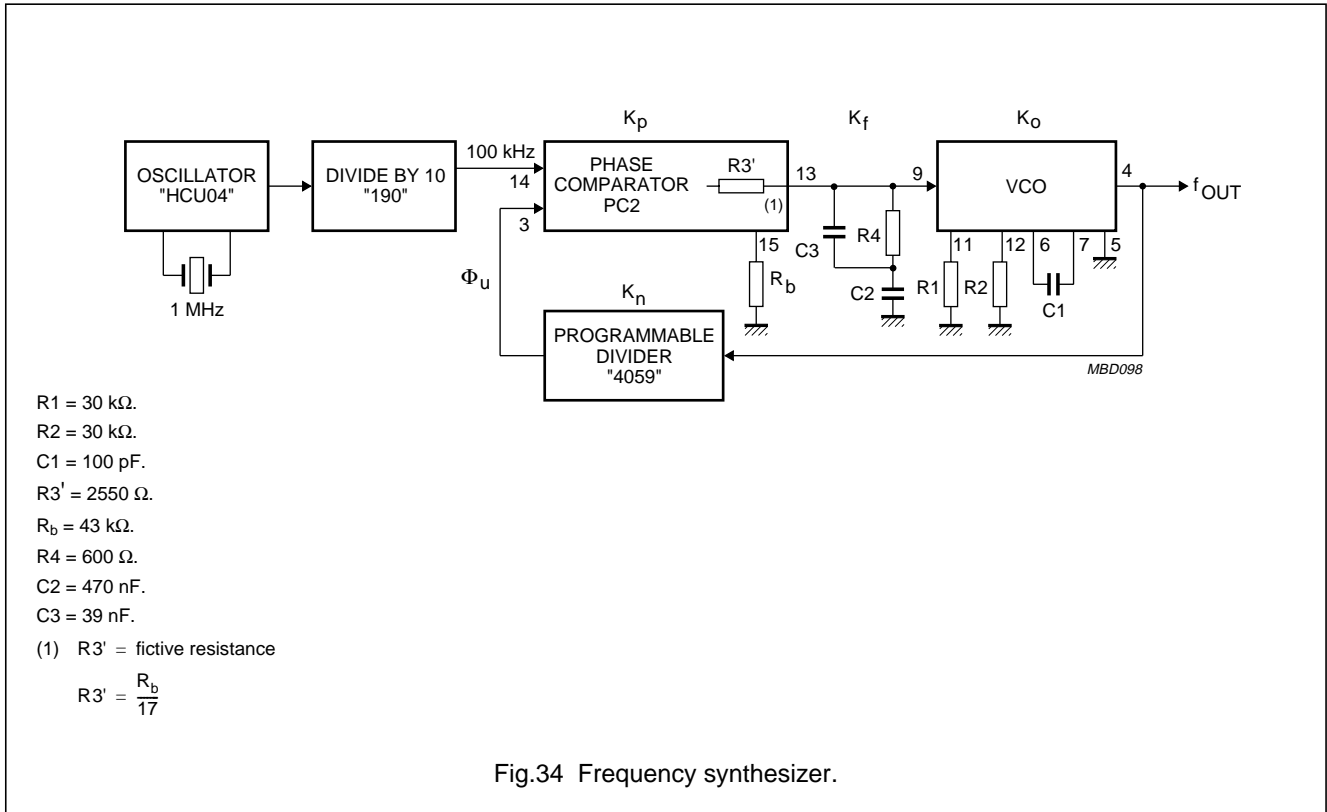


Fig.34 Frequency synthesizer.

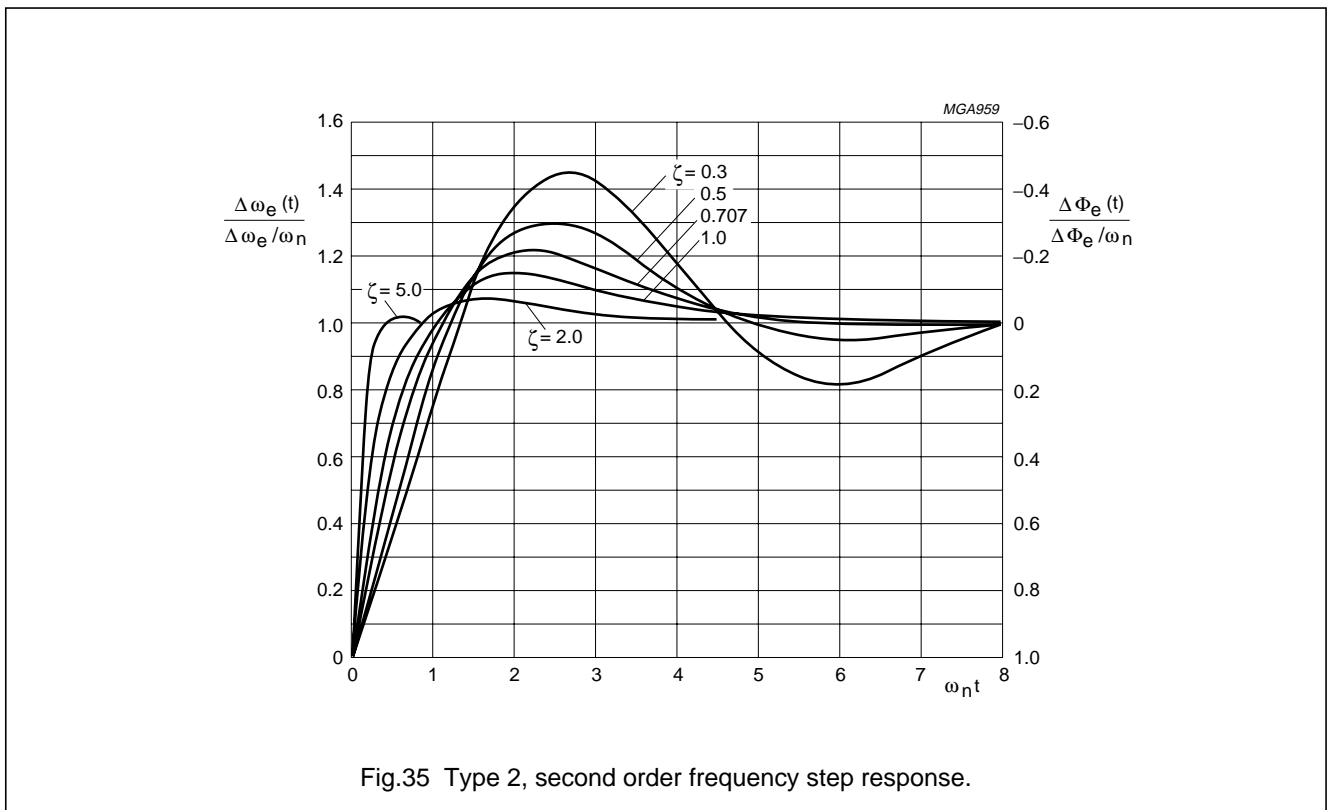


Fig.35 Type 2, second order frequency step response.

# PLL with bandgap controlled VCO

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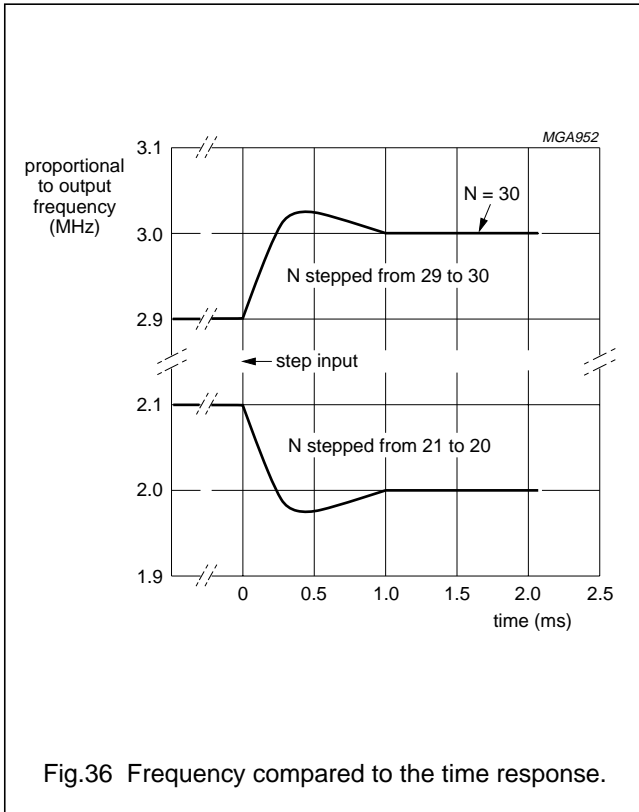


Fig.36 Frequency compared to the time response.

Since the output frequency is proportional to the VCO control voltage, the PLL frequency response can be observed with an oscilloscope by monitoring pin 9 of the VCO. The average frequency response, as calculated by the Laplace method, is found experimentally by smoothing this voltage at pin 9 with a simple RC filter, whose time constant is long compared with the phase detector sampling rate but short compared with the PLL response time.

### Further information

For an extensive description and application example please refer to "Application note" ordering number 9398 649 90011. Also available a "Computer design program for PLLs" ordering number 9398 961 10061.

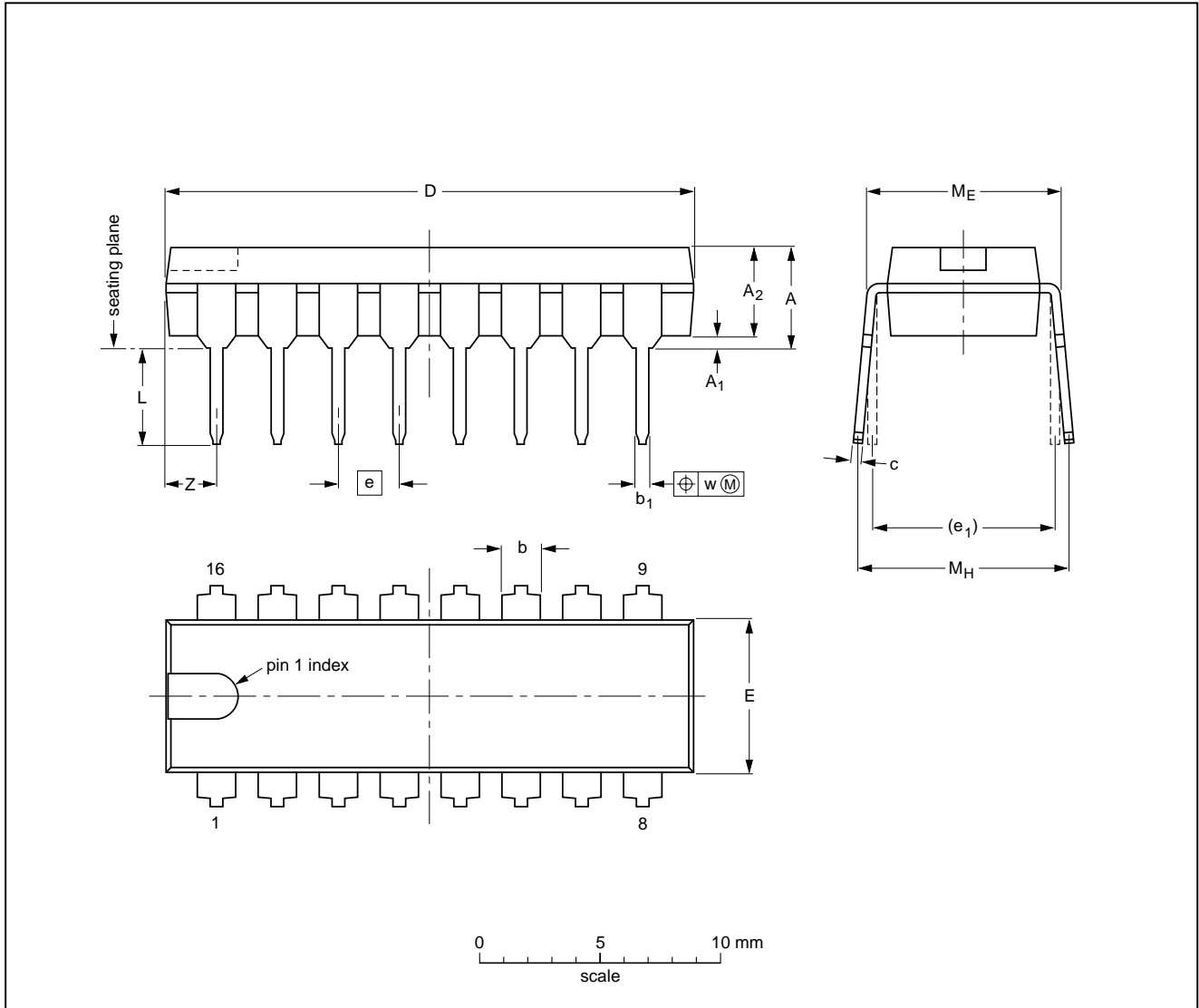
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PACKAGE OUTLINES

DIP16: plastic dual in-line package; 16 leads (300 mil); long body

SOT38-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A <sub>1</sub> min.	A <sub>2</sub> max.	b	b <sub>1</sub>	c	D <sup>(1)</sup>	E <sup>(1)</sup>	e	e <sub>1</sub>	L	M <sub>E</sub>	M <sub>H</sub>	w	z <sup>(1)</sup> max.
mm	4.7	0.51	3.7	1.40 1.14	0.53 0.38	0.32 0.23	21.8 21.4	6.48 6.20	2.54	7.62	3.9 3.4	8.25 7.80	9.5 8.3	0.254	2.2
inches	0.19	0.020	0.15	0.055 0.045	0.021 0.015	0.013 0.009	0.86 0.84	0.26 0.24	0.10	0.30	0.15 0.13	0.32 0.31	0.37 0.33	0.01	0.087

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

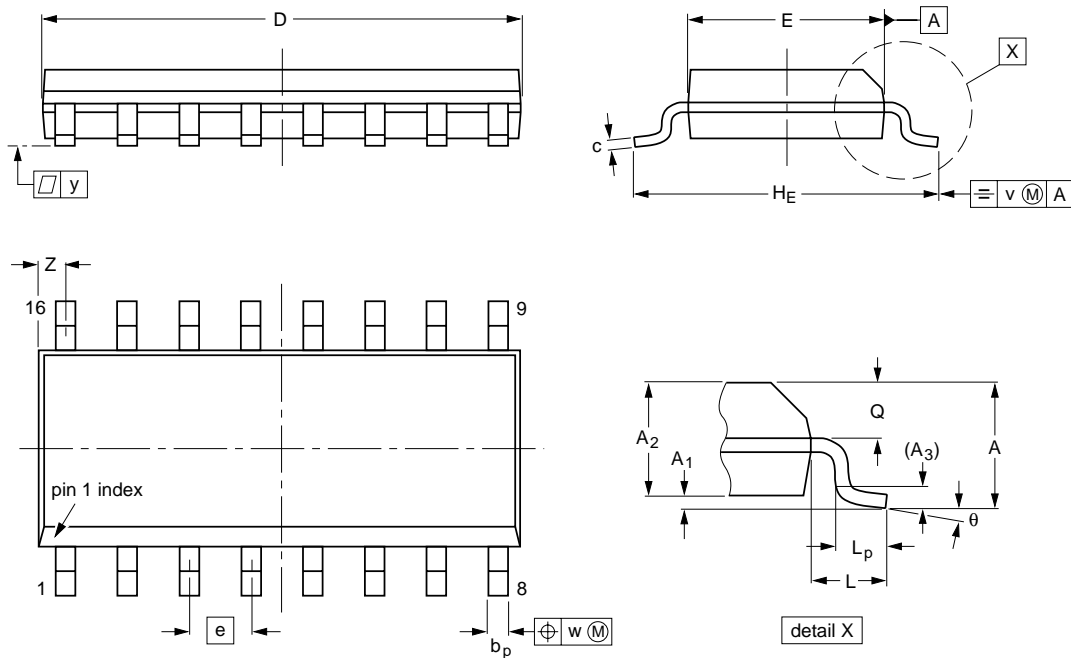
OUTLINE VERSION	REFERENCES			EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ		
SOT38-1	050G09	MO-001AE			92-10-02 95-01-19

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SO16: plastic small outline package; 16 leads; body width 3.9 mm

SOT109-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	b <sub>p</sub>	c	D <sup>(1)</sup>	E <sup>(1)</sup>	e	H <sub>E</sub>	L	L <sub>p</sub>	Q	v	w	y	z <sup>(1)</sup>	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	10.0 9.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8° 0°
inches	0.069	0.010 0.004	0.057 0.049	0.01	0.019 0.014	0.0100 0.0075	0.39 0.38	0.16 0.15	0.050	0.244 0.228	0.041	0.039 0.016	0.028 0.020	0.01	0.01	0.004	0.028 0.012	

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT109-1	076E07S	MS-012AC				95-01-23 97-05-22

## PLL with bandgap controlled VCO

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### SOLDERING

#### Introduction

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our *"Data Handbook IC26; Integrated Circuit Packages"* (document order number 9398 652 90011).

There is no soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and surface mount components are mixed on one printed-circuit board. However, wave soldering is not always suitable for surface mount ICs, or for printed-circuit boards with high population densities. In these situations reflow soldering is often used.

#### Through-hole mount packages

##### SOLDERING BY DIPPING OR BY SOLDER WAVE

The maximum permissible temperature of the solder is 260 °C; solder at this temperature must not be in contact with the joints for more than 5 seconds. The total contact time of successive solder waves must not exceed 5 seconds.

The device may be mounted up to the seating plane, but the temperature of the plastic body must not exceed the specified maximum storage temperature ( $T_{stg(max)}$ ). If the printed-circuit board has been pre-heated, forced cooling may be necessary immediately after soldering to keep the temperature within the permissible limit.

##### MANUAL SOLDERING

Apply the soldering iron (24 V or less) to the lead(s) of the package, either below the seating plane or not more than 2 mm above it. If the temperature of the soldering iron bit is less than 300 °C it may remain in contact for up to 10 seconds. If the bit temperature is between 300 and 400 °C, contact may be up to 5 seconds.

#### Surface mount packages

##### REFLOW SOLDERING

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement.

Several methods exist for reflowing; for example, infrared/convection heating in a conveyor type oven. Throughput times (preheating, soldering and cooling) vary between 100 and 200 seconds depending on heating method.

Typical reflow peak temperatures range from 215 to 250 °C. The top-surface temperature of the packages should preferably be kept below 230 °C.

##### WAVE SOLDERING

Conventional single wave soldering is not recommended for surface mount devices (SMDs) or printed-circuit boards with a high component density, as solder bridging and non-wetting can present major problems.

To overcome these problems the double-wave soldering method was specifically developed.

If wave soldering is used the following conditions must be observed for optimal results:

- Use a double-wave soldering method comprising a turbulent wave with high upward pressure followed by a smooth laminar wave.
  - For packages with leads on two sides and a pitch (e):
    - larger than or equal to 1.27 mm, the footprint longitudinal axis is **preferred** to be parallel to the transport direction of the printed-circuit board;
    - smaller than 1.27 mm, the footprint longitudinal axis **must** be parallel to the transport direction of the printed-circuit board.
- The footprint must incorporate solder thieves at the downstream end.
- For packages with leads on four sides, the footprint must be placed at a 45° angle to the transport direction of the printed-circuit board. The footprint must incorporate solder thieves downstream and at the side corners.

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Typical dwell time is 4 seconds at 250 °C.

A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

##### MANUAL SOLDERING

Fix the component by first soldering two diagonally-opposite end leads. Use a low voltage (24 V or less) soldering iron applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to 300 °C.

When using a dedicated tool, all other leads can be soldered in one operation within 2 to 5 seconds between 270 and 320 °C.

## PLL with bandgap controlled VCO

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## Suitability of IC packages for wave, reflow and dipping soldering methods

MOUNTING	PACKAGE	SOLDERING METHOD		
		WAVE	REFLOW <sup>(1)</sup>	DIPPING
Through-hole mount	DBS, DIP, HDIP, SDIP, SIL	suitable <sup>(2)</sup>	–	suitable
Surface mount	BGA, SQFP	not suitable	suitable	–
	HLQFP, HSQFP, HSOP, HTSSOP, SMS	not suitable <sup>(3)</sup>	suitable	–
	PLCC <sup>(4)</sup> , SO, SOJ	suitable	suitable	–
	LQFP, QFP, TQFP	not recommended <sup>(4)(5)</sup>	suitable	–
	SSOP, TSSOP, VSO	not recommended <sup>(6)</sup>	suitable	–

## Notes

1. All surface mount (SMD) packages are moisture sensitive. Depending upon the moisture content, the maximum temperature (with respect to time) and body size of the package, there is a risk that internal or external package cracks may occur due to vaporization of the moisture in them (the so called popcorn effect). For details, refer to the Drypack information in the “Data Handbook IC26; Integrated Circuit Packages; Section: Packing Methods”.
2. For SDIP packages, the longitudinal axis must be parallel to the transport direction of the printed-circuit board.
3. These packages are not suitable for wave soldering as a solder joint between the printed-circuit board and heatsink (at bottom version) can not be achieved, and as solder may stick to the heatsink (on top version).
4. If wave soldering is considered, then the package must be placed at a 45° angle to the solder wave direction. The package footprint must incorporate solder thieves downstream and at the side corners.
5. Wave soldering is only suitable for LQFP, QFP and TQFP packages with a pitch (e) equal to or larger than 0.8 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.65 mm.
6. Wave soldering is only suitable for SSOP and TSSOP packages with a pitch (e) equal to or larger than 0.65 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.5 mm.

## DEFINITIONS

Data sheet status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
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